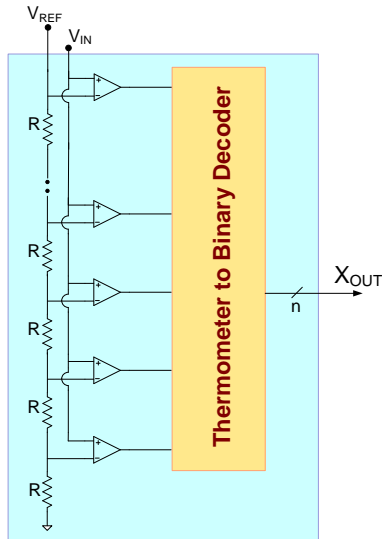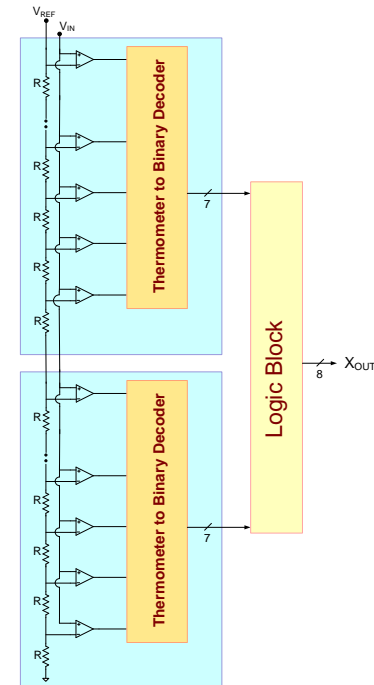# EE 435

Lecture 38

Switched-Capacitor Amplifiers and Switched-Capacitor Filters

How important is statistical analysis?

Example: What will be the yield if two of the 7-bit FLASH ADCs with yields of 98.8% are combined to obtain an 8-bit ADC?


$Y_{ADC} = 98.8\%$

$Y_{ADC} = 1.52 \bullet 10^{-6}$

- The onset of statistically-induced yield loss can be abrupt
- Intuition is not an acceptable substitute to statistical analysis
- Without statistical analysis/simulation there is a high probability that a data converter will be substantially over designed or under designed and neither is acceptable

String DAC Statistical Performance

standard deviation of INL_k assumes a maximum variance at mid-code
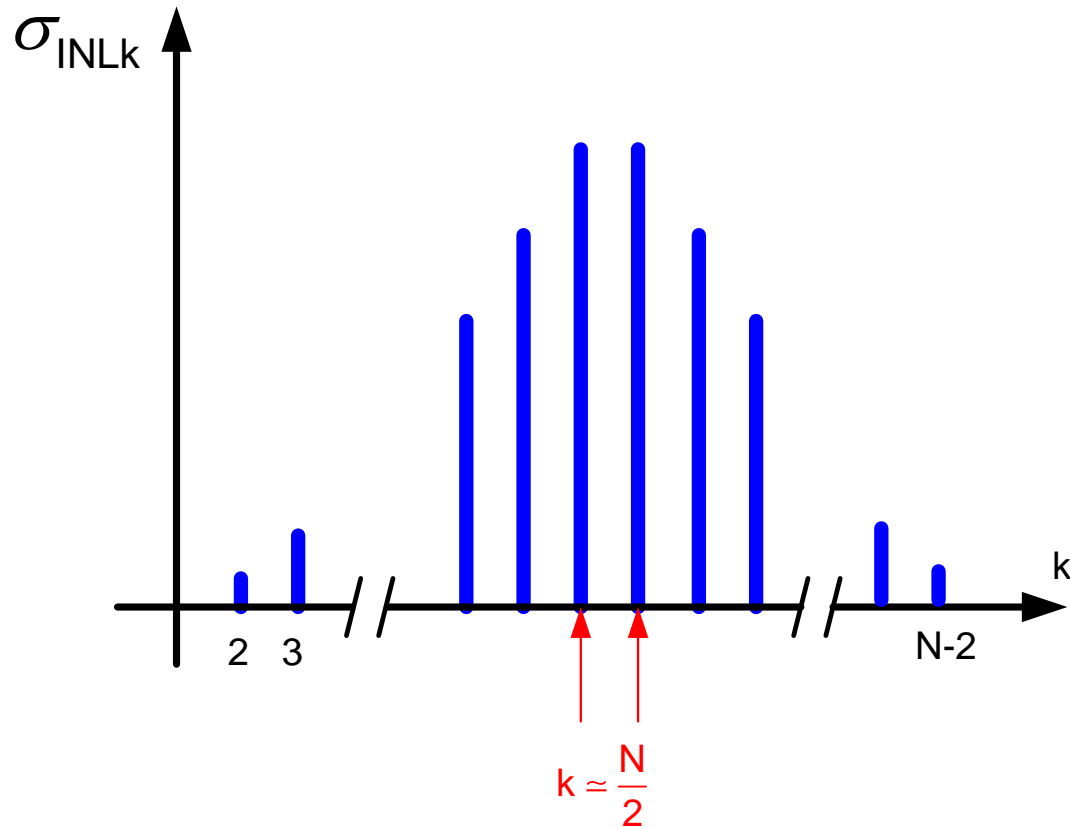
It can be shown that INL_k is Gaussian and

$$\sigma_{INLk\,\text{max}} = \sigma_{\frac{R_R}{R_{NOM}}} \frac{\sqrt{N}}{2}$$

Example 3: What area is needed for obtaining a 99% yield for an 8-bit string DAC and how does that compare to the area required for a 7-bit DAC with the same yield?
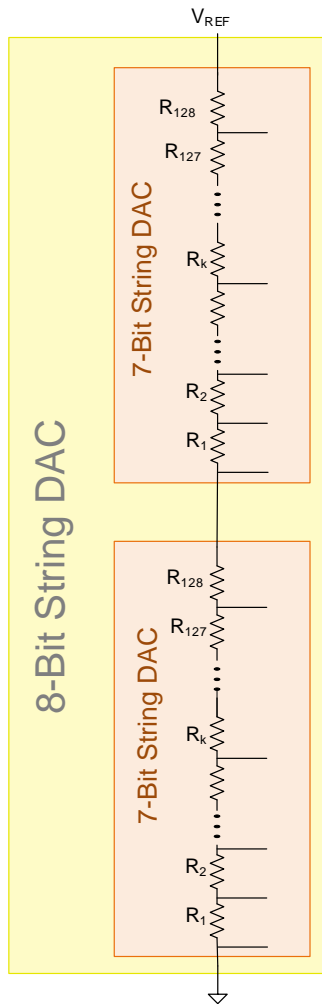
For 99% yield

$$\sigma_z = \sigma_{\frac{R}{R_N}} \bullet \frac{\sqrt{N}}{2} = \frac{A_\rho}{\sqrt{A}} \bullet \frac{\sqrt{N}}{2} = 0.388$$

$$\frac{A_\rho}{\sqrt{A}} \bullet \frac{\sqrt{N}}{2} = 0.388$$

$$A_\rho = 0.1\mu m \qquad N = 256$$

$$A = 4.25\,\mu m^2$$

Area doubled because there are twice as many resistors and each is approximately twice as big so by adding 1-bit of resolution, the area went up by approximately a factor of 4

V_REF

8-Bit String DAC

7-Bit String DAC

R_{128}
R_{127}
R_k
R_2
R_1

7-Bit String DAC

R_{128}
R_{127}
R_k
R_2
R_1

How important is statistical analysis?

- Statistical analysis of data converters is critical

- Some architectures are more sensitive than others to statistical variations in components

- The onset of yield loss due to statistical limitations is generally quite abrupt and can have disastrous effects if not considered as part of the design process

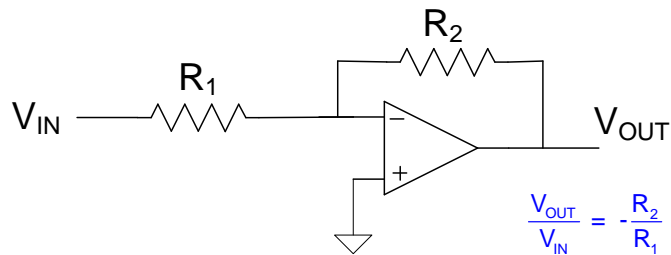 Recall examples where σ_{VOS}=5mV compared with σ_{VOS}=1mV

- Substantially over-designing to avoid concerns about statistical yield loss is not a practical solution since the area penalty, the speed penalty, and the power penalty are generally quite severe

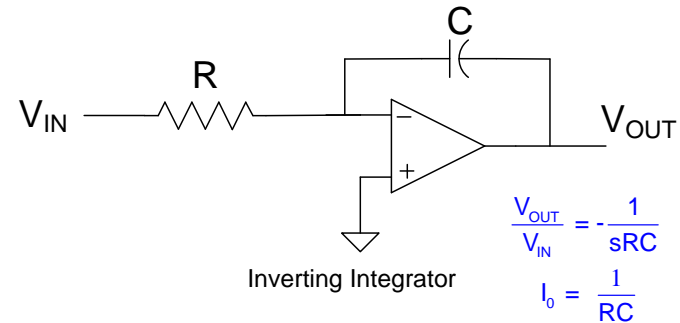For the effects of local random variations of a parameter X, generally

$$\sigma_X \propto \frac{A_0}{\sqrt{A_C}}$$

where A_C is the area of the matching critical components and A_0 is a process parameter
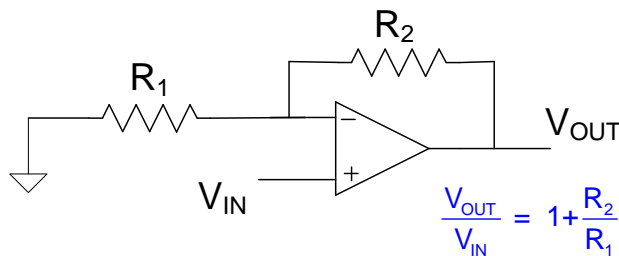
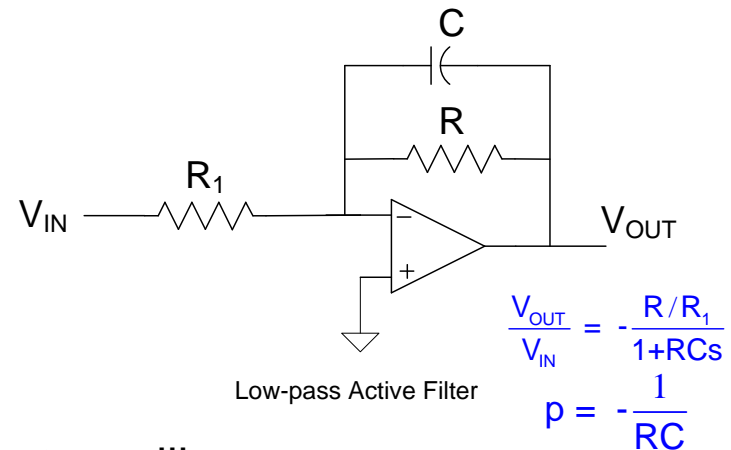# Some of the most basic and widely used analog circuits

Inverting Amplifier

$$\frac{V_{OUT}}{V_{IN}} = -\frac{R_2}{R_1}$$

Inverting Integrator

$$\frac{V_{OUT}}{V_{IN}} = -\frac{1}{sRC}$$

$$l_0 = \frac{1}{RC}$$

Noninverting Amplifier

$$\frac{V_{OUT}}{V_{IN}} = 1 + \frac{R_2}{R_1}$$

Low-pass Active Filter

$$\frac{V_{OUT}}{V_{IN}} = -\frac{R/R_1}{1+RCs}$$

$$p = -\frac{1}{RC}$$

Not practical to implement on silicon

- Area for R too big
- Area for C too big
- Accuracy of l_0 and p too poor

But ratio accuracy can be very good (0.1% or better with good layout and appropriate area)

How bad is the problem?

PROCESS PARAMETERS	N+ACTV	P+ACTV	POLY	PLY2_HR	POLY2	MTL1	MTL2	UNITS
Sheet Resistance	82.7	103.2	21.7	984	39.7	0.09	0.09	ohms/sq
Contact Resistance	56.2	118.4	14.6		24.0		0.78	ohms
Gate Oxide Thickness	144							angstrom

PROCESS PARAMETERS	MTL3	N\PLY	N_WELL	UNITS
Sheet Resistance	0.05	824	815	ohms/sq
Contact Resistance	0.78			ohms

COMMENTS: N\POLY is N-well under polysilicon.

CAPACITANCE PARAMETERS	N+ACTV	P+ACTV	POLY	POLY2	M1	M2	M3	N_WELL	UNITS
Area (substrate)	429	721	82		32	17	10	40	aF/um^2
Area (N+active)			2401		36	16	12		aF/um^2
Area (P+active)			2308						aF/um^2
Area (poly)				864	61	17	9		aF/um^2
Area (poly2)					53				aF/um^2
Area (metal1)						34	13		aF/um^2
Area (metal2)							32		aF/um^2
Fringe (substrate)	311	256			74	58	39		aF/um
Fringe (poly)					53	40	28		aF/um
Fringe (metal1)						55	32		aF/um
Fringe (metal2)							48		aF/um
Overlap (N+active)			206						aF/um
Overlap (P+active)			278						aF/um

$R_\square = 21.7\,\Omega/\square$ and $C_d = 0.864\,fF/\mu^2$

How bad is the problem?

$$\frac{V_{OUT}}{V_{IN}} = -\frac{R/R_1}{1+RCs}$$

Low-pass Active Filter

$$p = -\frac{1}{RC}$$

$$K_0 = 1 + \frac{R_2}{R_1}$$

$$BW_{rad/sec} = -p = \frac{1}{RC}$$

Assume $|p|=2\pi\cdot1K$ and pole accuracy needed is 0.1%

Process tolerance on R and C is about ±20%

$R\square=20\Omega/\square$ and $Cd=1pF/\mu^2$ (approximately)
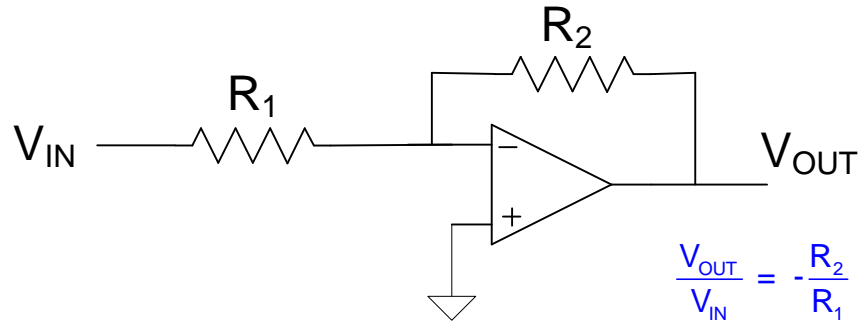
If R=1K, require 1000/20=50 squares

$$\frac{1}{RC} = 2000\pi \qquad C = \frac{1}{R\cdot2000\pi} \qquad C = \frac{1}{1000\cdot2000\pi} = 0.159\mu F$$

$$A_C = \frac{C}{C_D} = \frac{0.159\mu F}{1fF/\mu^2} = 1.59\times10^8\,\mu^2$$

Pole tolerance ±40%

Both are orders of magnitude unacceptable !

An amplifier alternative ?

$$\frac{V_{OUT}}{V_{IN}} = -\frac{R_2}{R_1}$$

Inverting Amplifier

$$\frac{V_{OUT}}{V_{IN}} = -\frac{C_1}{C_2}$$
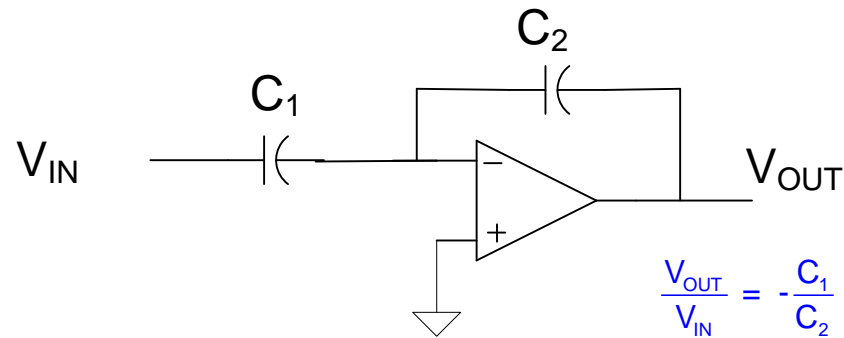
Inverting Amplifier

- Capacitor version is area effective and can have very good accuracy
- The node between C_1 and C_2 is a floating node if the Op Amp has a MOS differential pair at the input
- But if we get any charge on the intermediate node there is no way to get it off

An amplifier alternative ?:
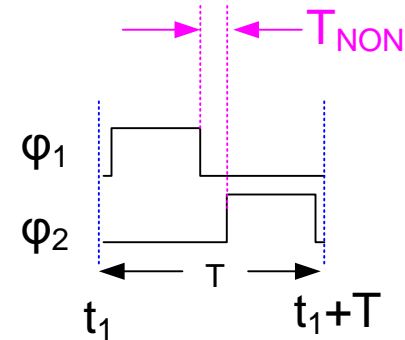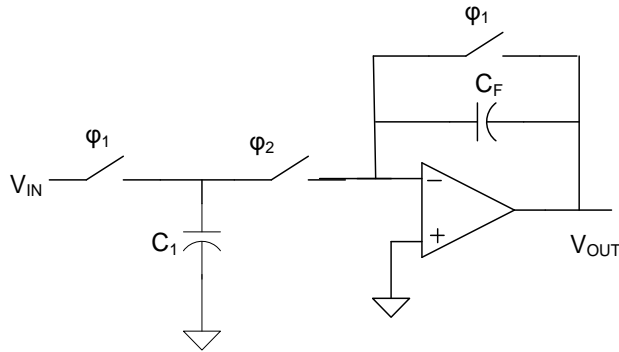
Φ_1 and Φ_2 are nonoverlapping clocks

During Φ_1

C_1 is charged to V_{IN} and stores charge $Q_1 = C_1 V_{IN}$

C_F is discharged and $V_{OUT} = 0$

During Φ_2

C_1 is discharged but charge is transferred to C_F

$Q_2 = -Q_1$ and $V_{OUT} = Q_2/C_F$

Substituting for Q_1 we obtain $\quad V_{OUT} = -\dfrac{C_1}{C_F} V_{IN}$

Serves as a voltage amplifier during φ_2

An amplifier alternative !
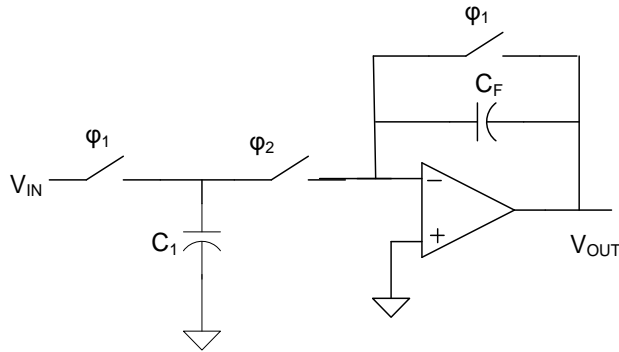
$$V_{OUT} = -\frac{C_1}{C_F} V_{IN}$$
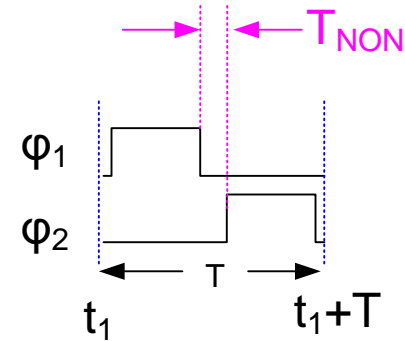
Φ_1 and Φ_2 are nonoverlapping clocks

- Many applications only need amplifier output at discrete points in time
- Accuracy can be very good
- Area can be very small

But, what about the switches?

Switches for SC Circuits
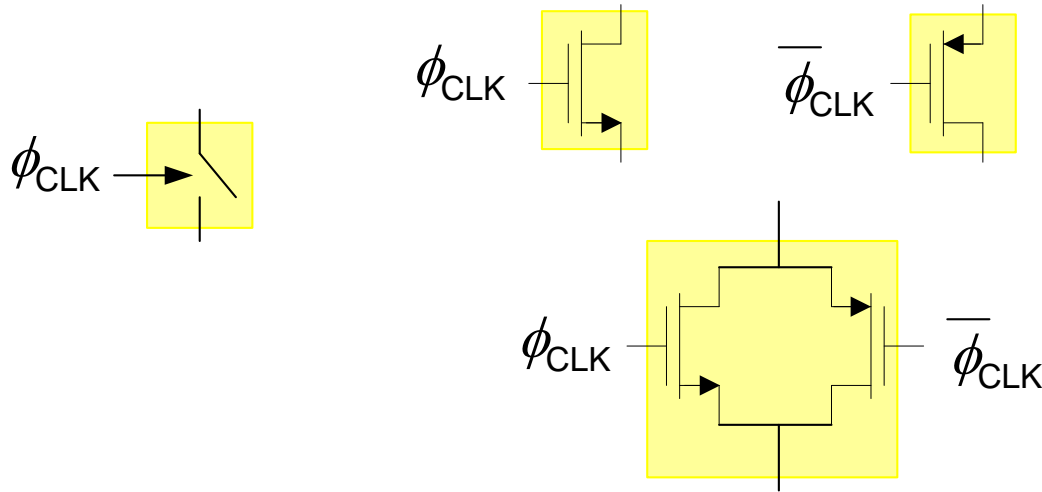
- Often a single MOS transistor is adequate (either n-ch or p-ch)
- Sometimes need transmission-gate switch (parallel n-ch and p-ch)
- Switches work very well and can be very small but must manage their R_{ON}

Parasitic Capacitances

C_{BS} C_{BD}

C

C_{Bc} C_{Tc}

?

φ_1

C_F

V_{IN} φ_1 φ_2

C_1

V_{OUT}
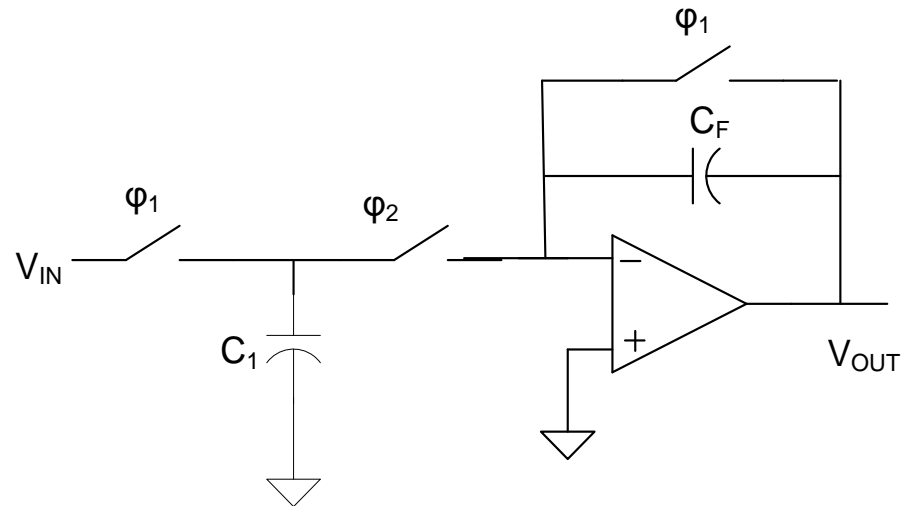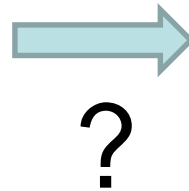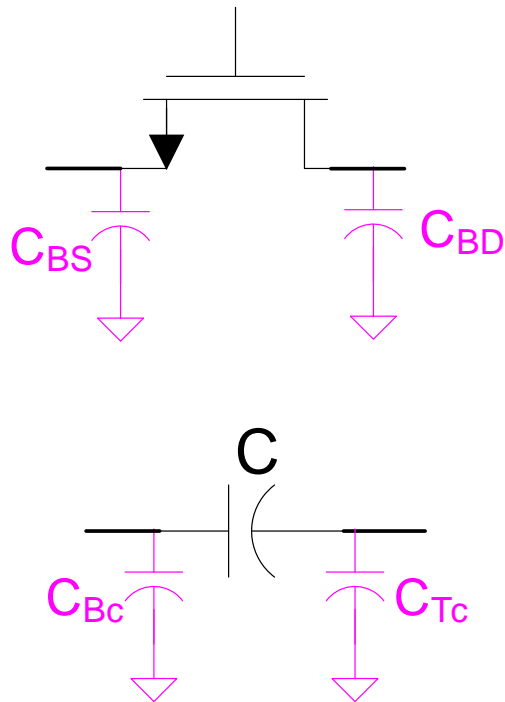
3 switches and 2 capacitors

10 parasitic capacitances!

Some of parasitic capacitances may be several percent of the size of C_1 and C_F

Parasitic Capacitances
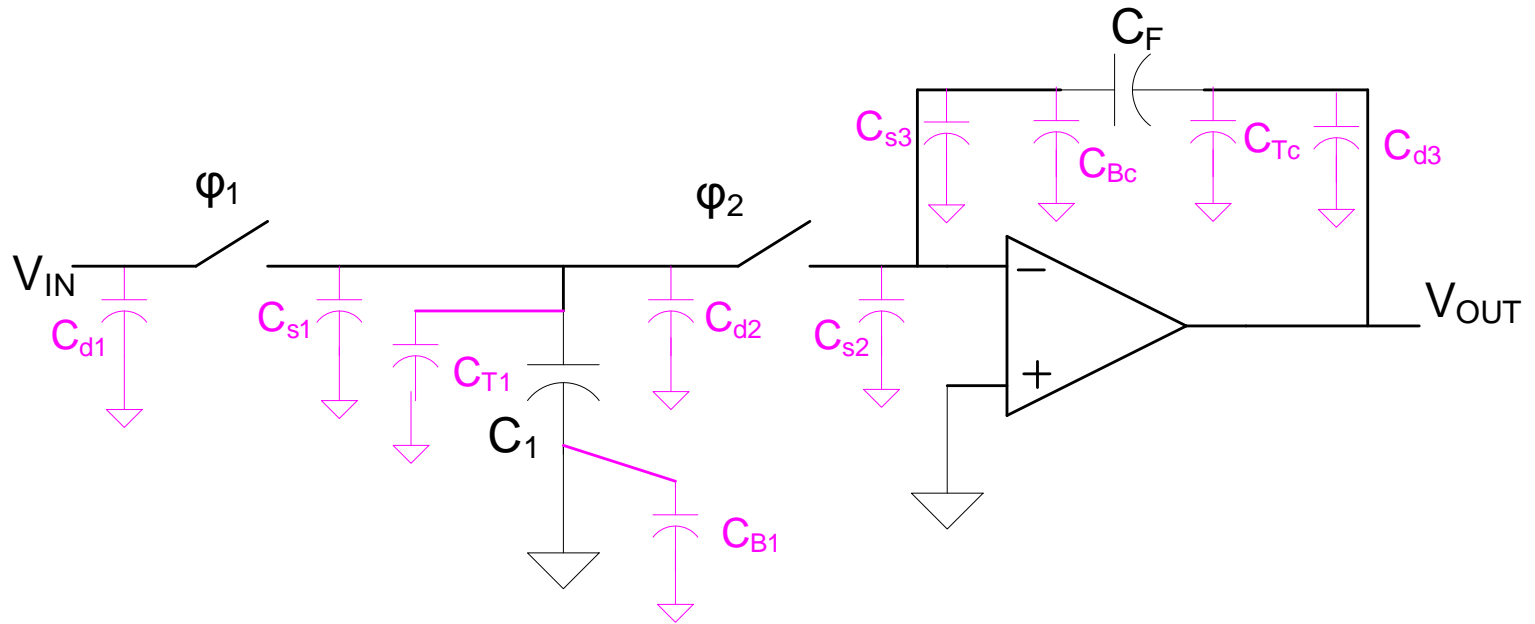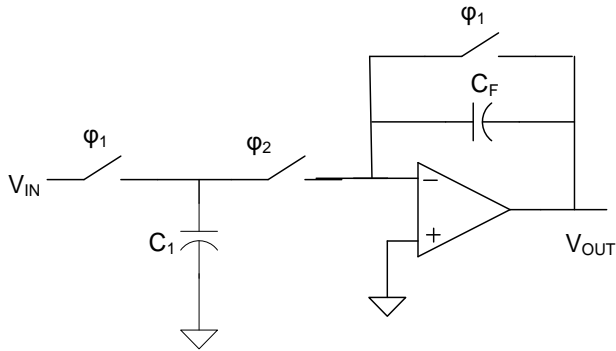
10 parasitic capacitances!

Stray Insensitive SC Amplifiers
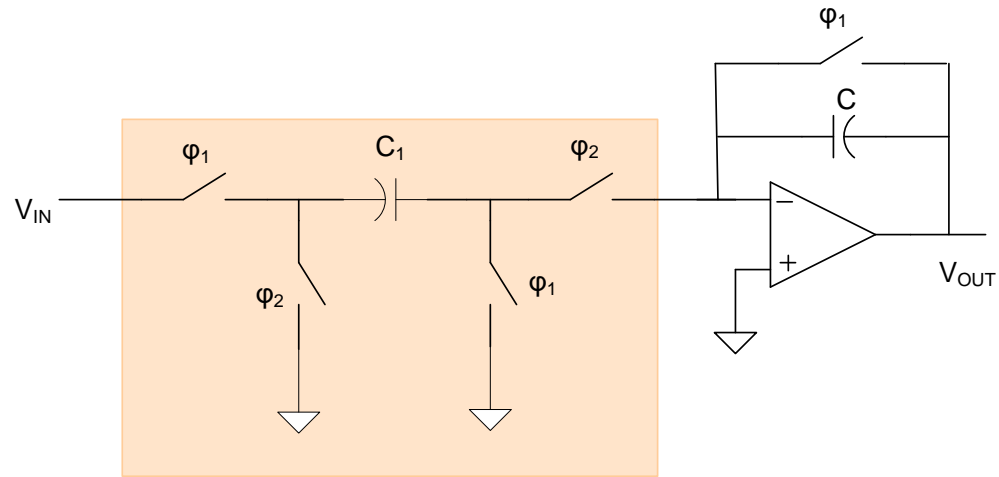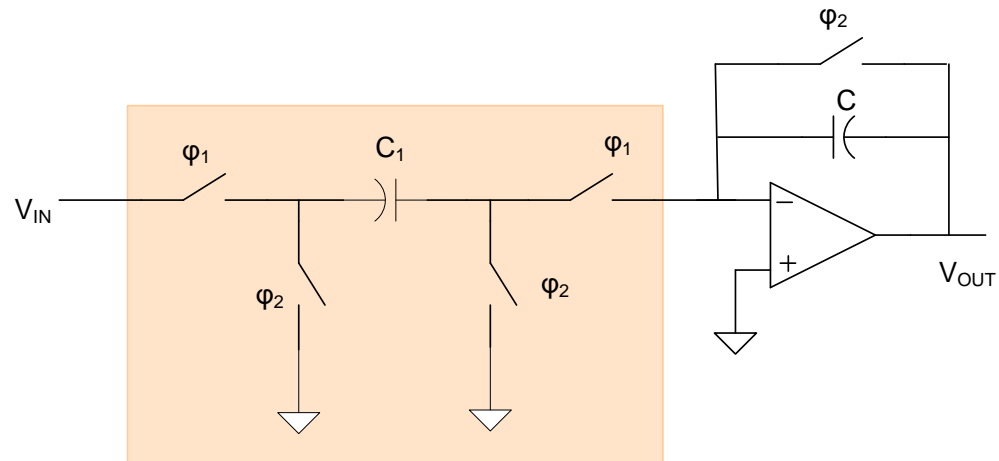
Noninverting

Ininverting

Can show that all diffusion parasitic capacitances do not affect gain

Stray Insensitive SC Amplifiers
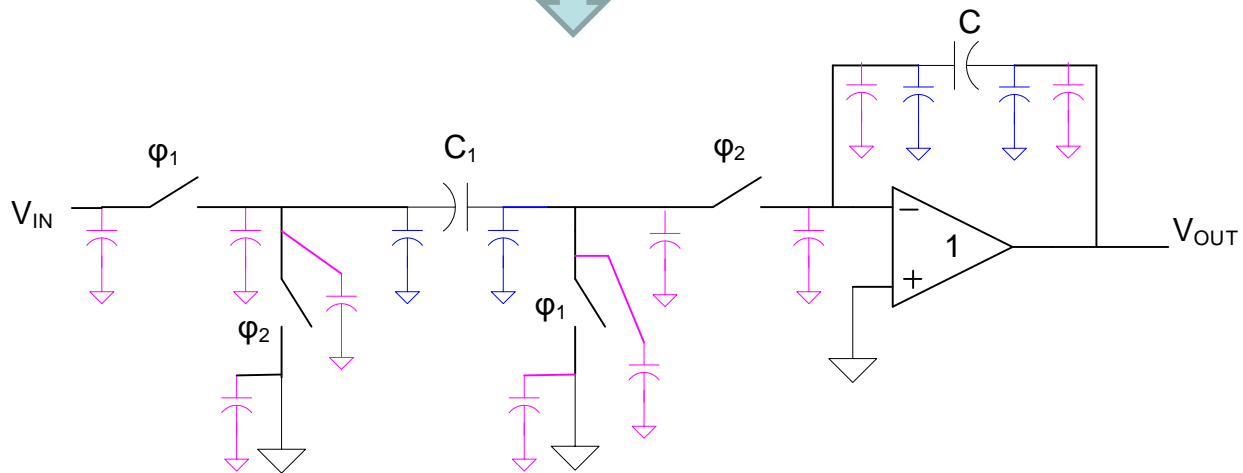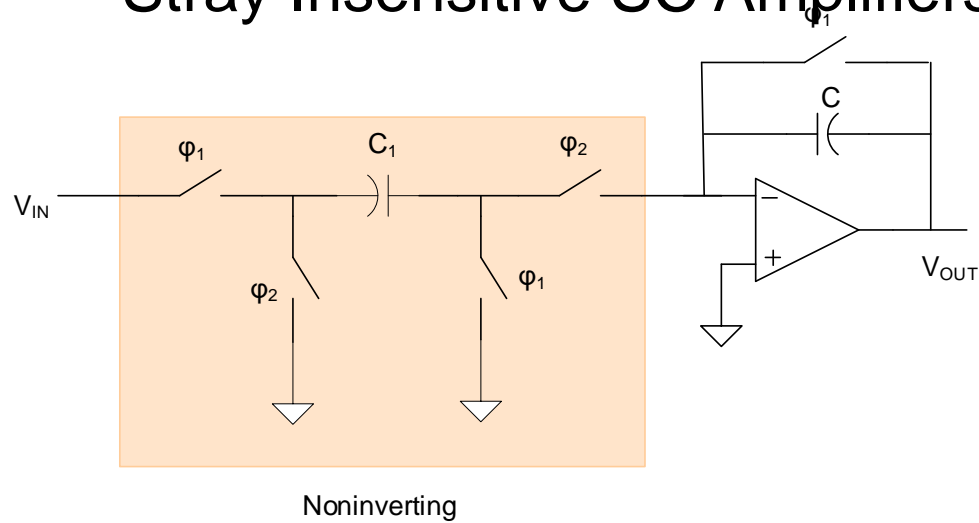
Noninverting

Can show that all 14 diffusion parasitic capacitances do not affect gain

Summing amplifier inputs either inverting or noninverting can be easily obtained
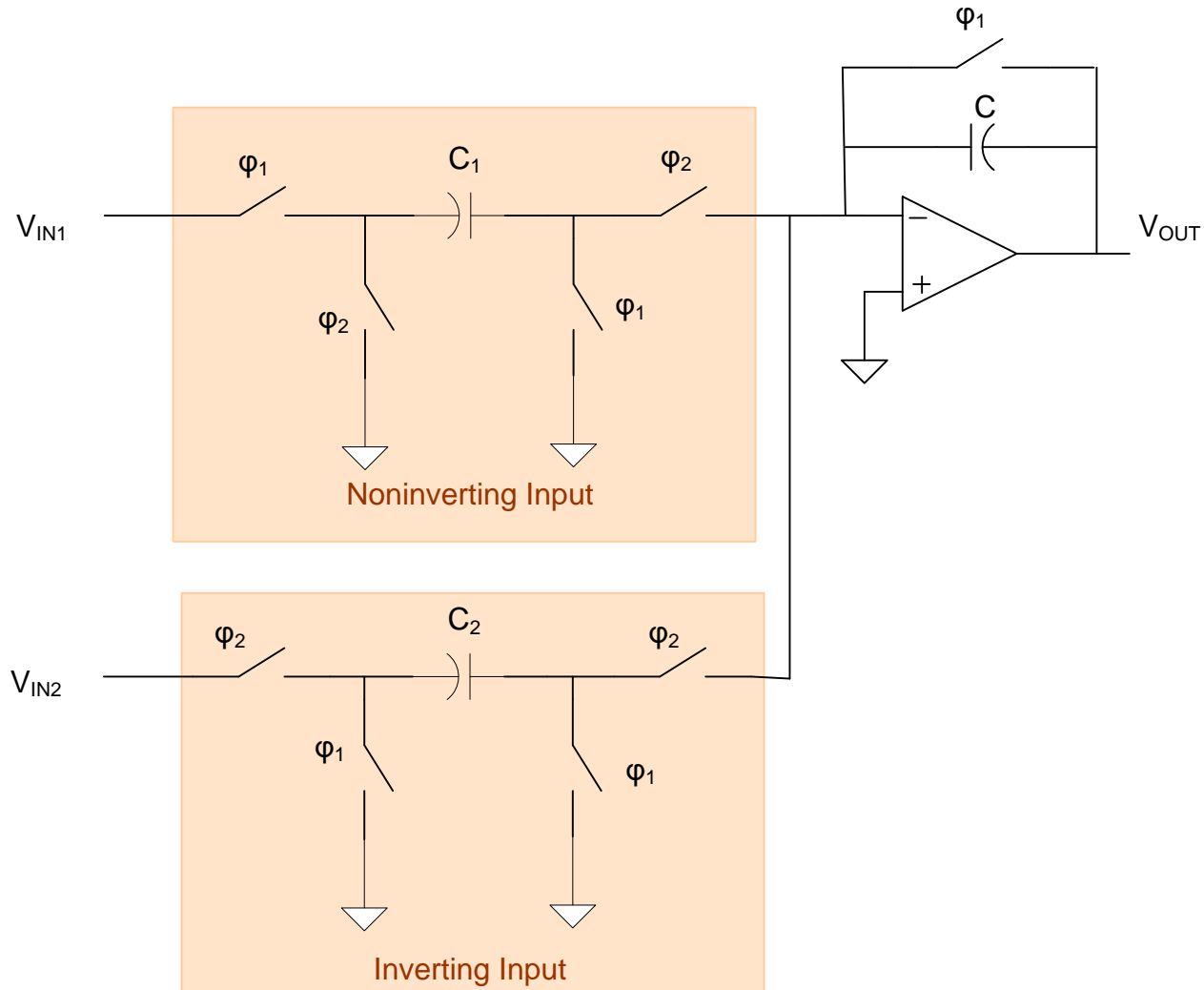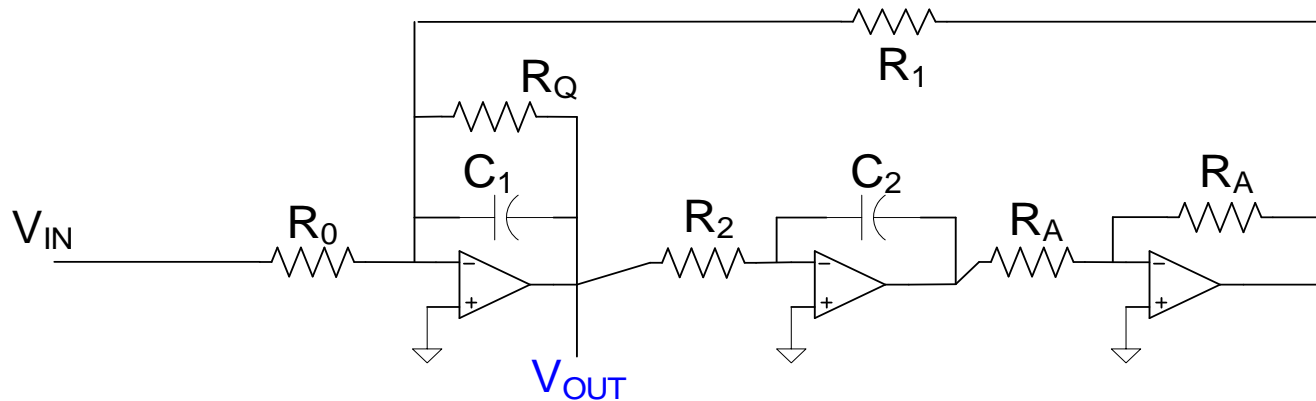
Consider the Basic Integrator
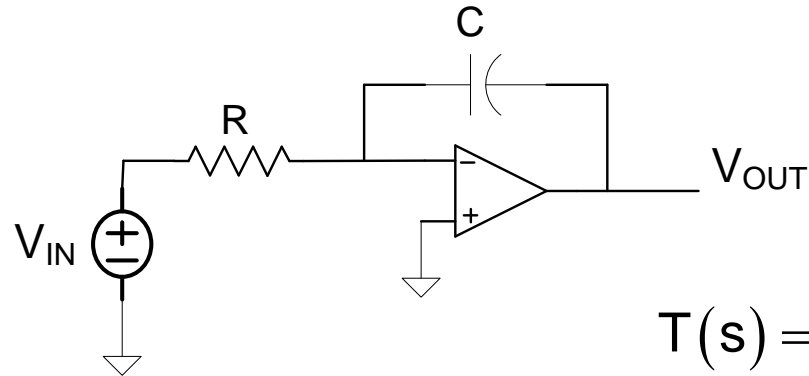
$$T(s) = -\frac{1}{RCs}$$

$$I_0 = \frac{1}{RC}$$

Key performance of integrator (and integrator-based filters) is determined by the integrator time constant I_0

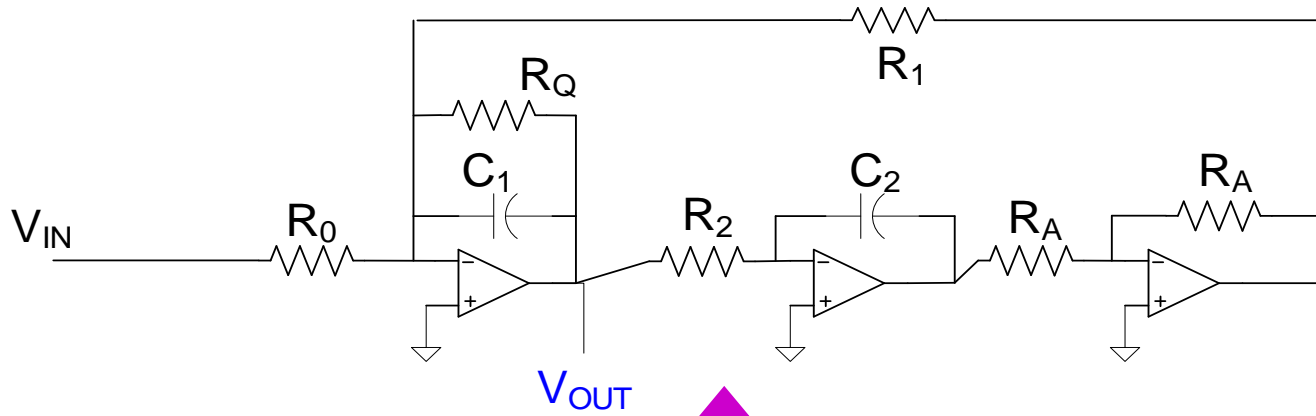Precision of time constants of a filter invariably determined by precision of I_0

Integrator-Based Filters:

$$\frac{V_{OUT}}{V_{IN}} = T(s) = -\frac{1}{R_0 C_1} \frac{s}{s^2 + s\left(\dfrac{1}{R_Q C_2}\right) + \dfrac{1}{R_1 R_2 C_1 C_2}}$$
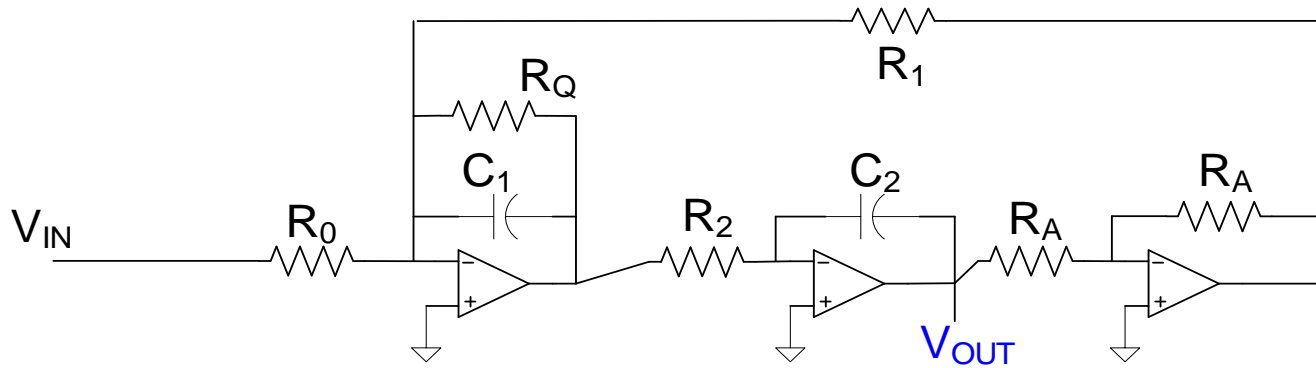
Second-order Bandpass Filter

Denote as a two-integrator-loop structure

# Integrator-Based Filters:
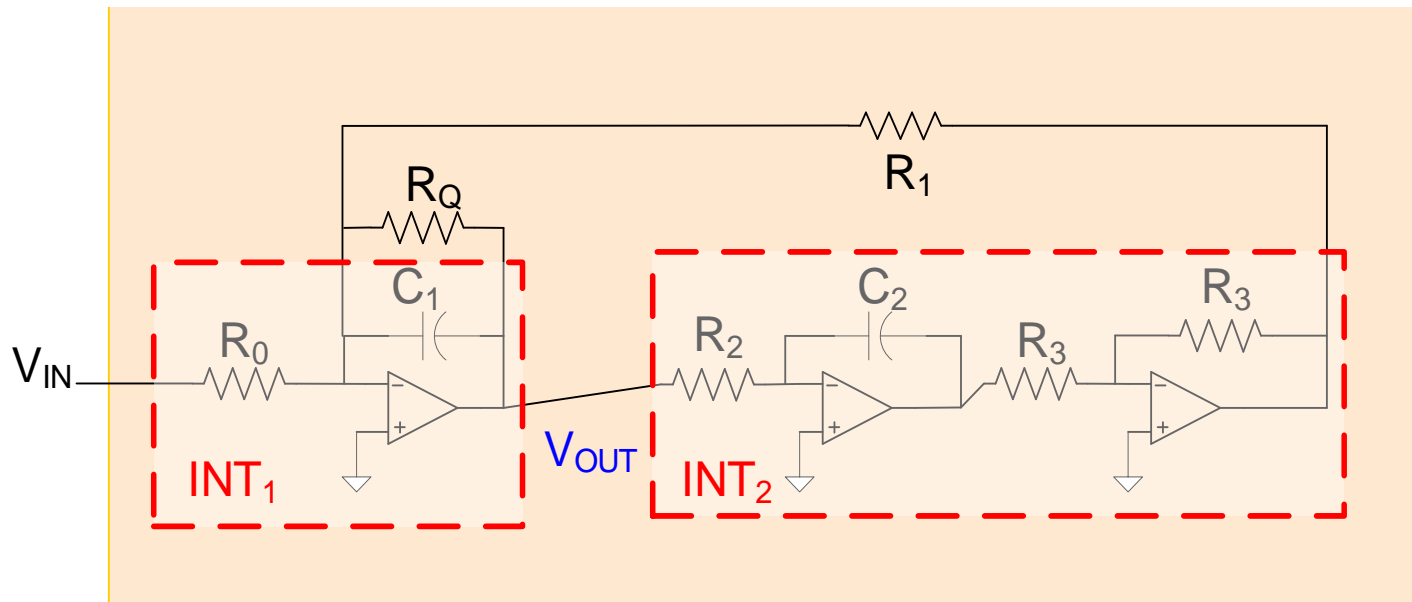
Integrator-Based Filters:

$$\frac{V_{OUT}}{V_{IN}} = T(s) = -\frac{1}{R_0 C_1} \frac{\dfrac{1}{R_2 C_2}}{s^2 + s\left(\dfrac{1}{R_Q C_2}\right) + \dfrac{1}{R_1 R_2 C_1 C_2}}$$

Second-order Lowpass Filter

Denote as a two-integrator-loop structure

- Any filter transfer function can be implemented with integrators and summers

- Some of the best known filter structures are based upon integrators and summers

- Accuracy of RC products is critical in the design of good filters

Consider the Basic Integrator
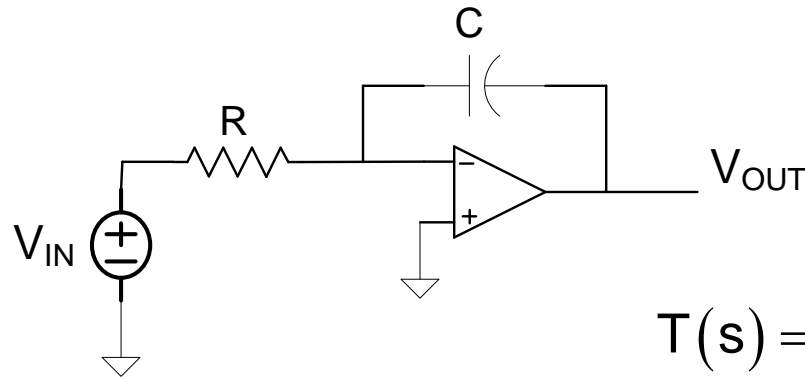
$$T(s) = -\frac{1}{RCs}$$

$$I_0 = \frac{1}{RC}$$

Accurate control of I_0 is required to build good filters !

1. Accuracy of R and C difficult to accurately control – particularly in integrated applications
   (often 2 or 3 orders of magnitude to variable)

2. Size of R and C unacceptably large if I_0 is in audio frequency range
   (2 or 3 orders of magnitude too large)

3. Amplifier GB limits performance

   Incredible Challenge to Building Filters on Silicon!

Integrator Design Issues
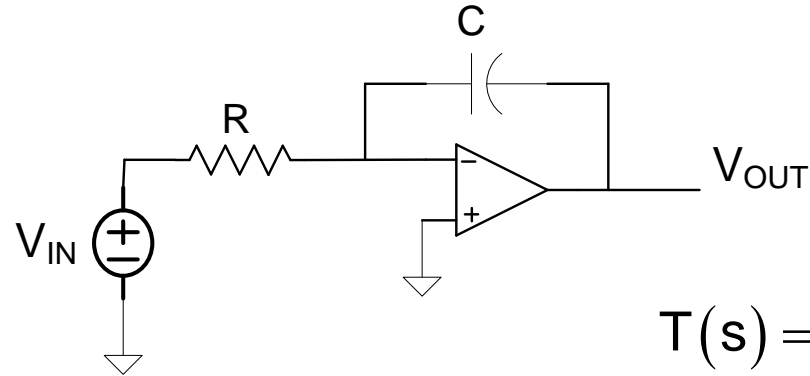
$$T(s) = -\frac{1}{RCs}$$
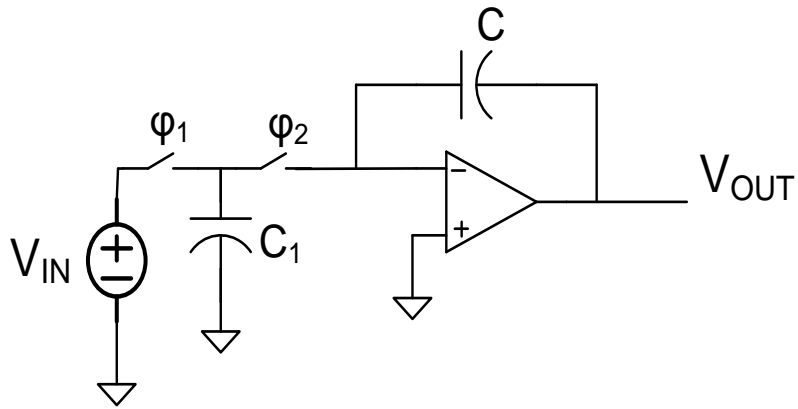
$$I_0 = \frac{1}{RC}$$

Consider:
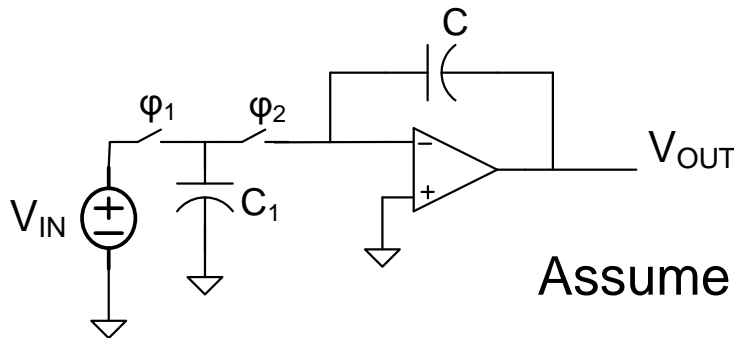
Assume $T_{CLK} << T_{SIG}$

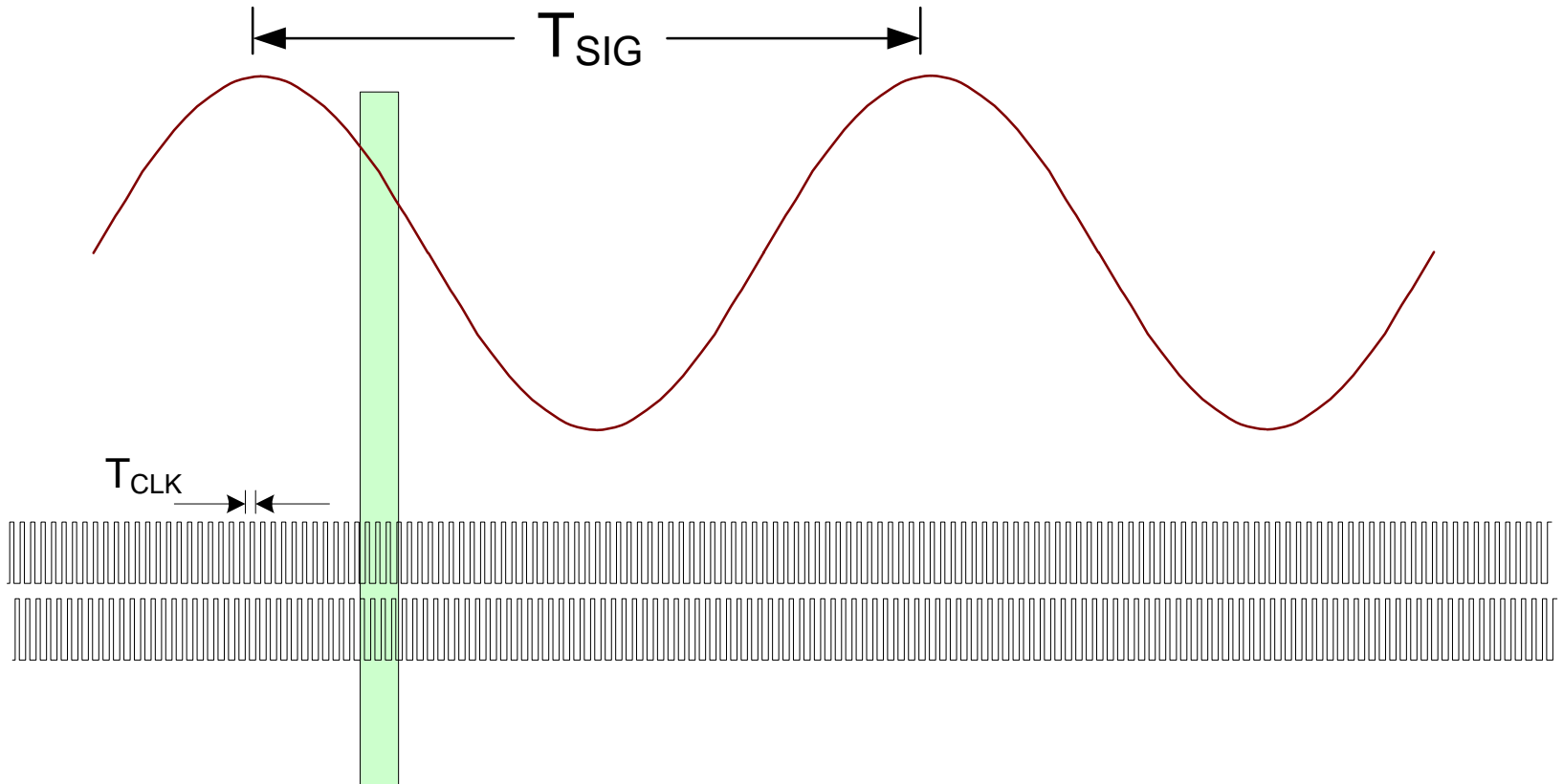Φ_1 and Φ_2 are complimenary nonoverlapping clocks

Termed a switched-capacitor circuit
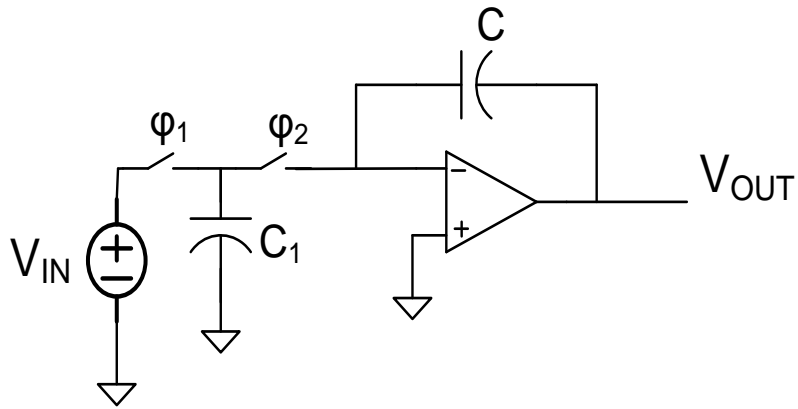
Consider the Switched-Capacitor Circuit

Assume $T_{CLK} << T_{SIG}$
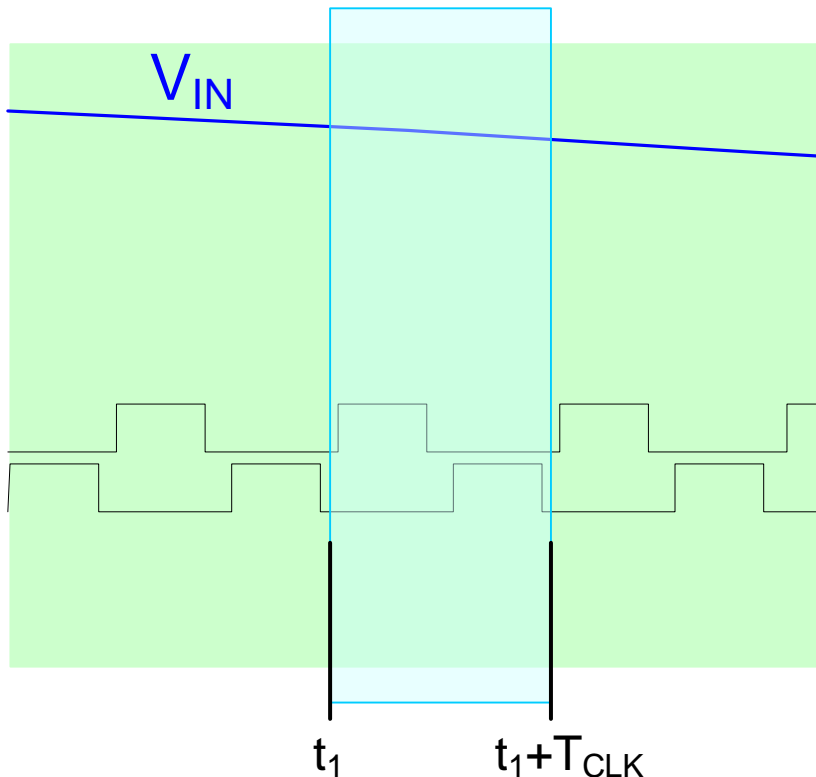
Φ_1 and Φ_2 are complimenary nonoverlapping clocks
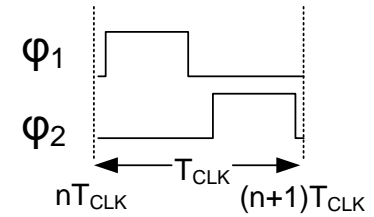
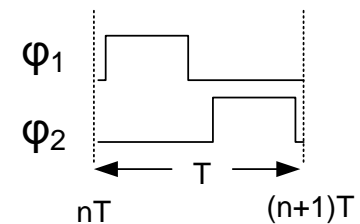# Consider the Switched-Capacitor Circuit

Assume $T_{CLK} << T_{SIG}$

Φ_1 and Φ_2 are complimenary nonoverlapping clocks

Compare the performance of the following two circuits
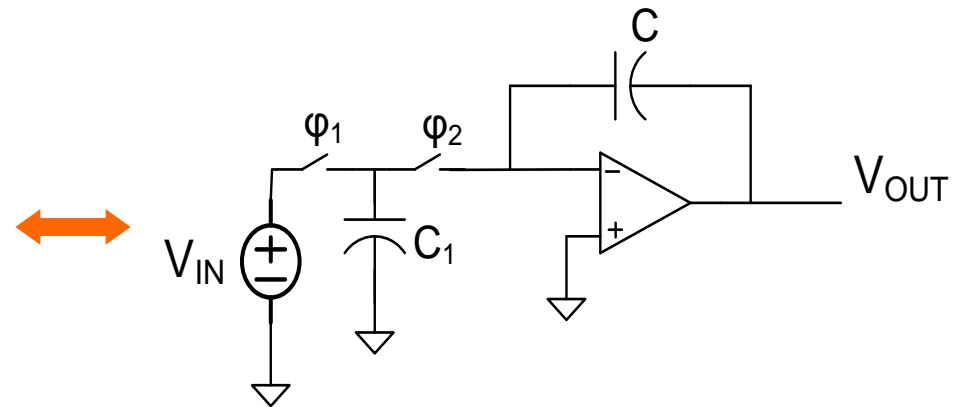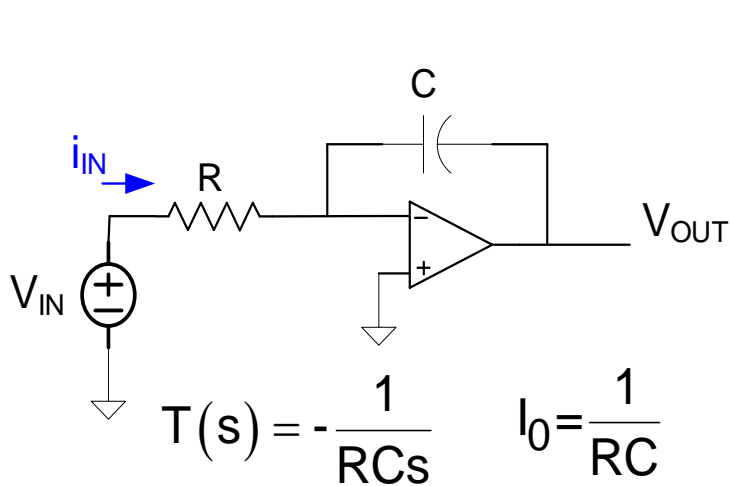
$$T(s) = -\frac{1}{RCs} \qquad I_0 = \frac{1}{RC}$$

Consider the charge transferred to the feedback capacitor
for both circuits in an interval of length T_{CLK} at arbitrary time t_1

For the RC circuit:
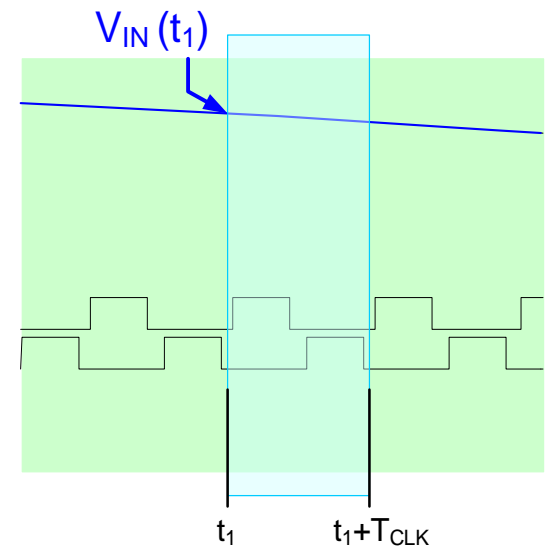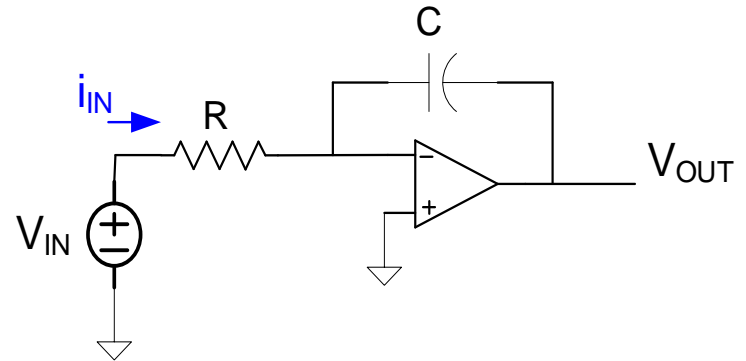
$$Q_{RC} = \int_{t_1}^{t_1+T_{CLK}} i_{in}(t)\,dt$$

$$Q_{RC} = \int_{t_1}^{t_1+T_{CLK}} \frac{V_{in}(t)}{R}\,dt$$

Since V_{in} changes slowly assume input is constant over one clock period

$$Q_{RC} \simeq \int_{t_1}^{t_1+T_{CLK}} \frac{V_{in}(t_1)}{R}\,dt$$

$$Q_{RC} \simeq \left[\frac{V_{in}(t_1)}{R}\right] \int_{t_1}^{t_1+T_{CLK}} 1\,dt$$

$$Q_{RC} \simeq \left[\frac{V_{in}(t_1)}{R}\right] T_{CLK}$$

Consider the charge transferred to the feedback capacitor
for both circuits in an interval of length T_{CLK} at time t_1

For the RC circuit:

$$Q_{RC} \simeq \left[\frac{V_{in}(t_1)}{R} \right] T_{CLK}$$

Observe that a resistor "transfers" charge proportional to V_{in} in a short interval
of T_{CLK}

For the SC circuit

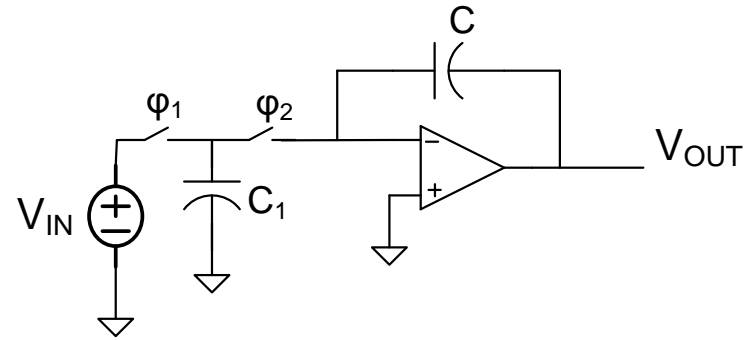$$Q_{C1} = C_1 V_{in} \left(t_1 + \frac{T_{CLK}}{2} - \varepsilon \right)$$
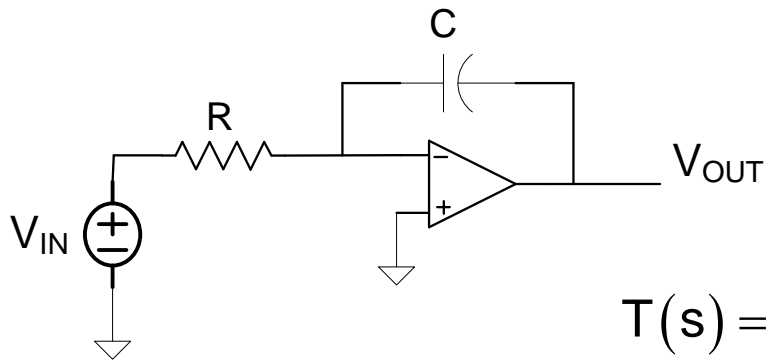
Since $V_{in}(t)$ is slowly varying

$$Q_{C1} \simeq C_1 V_{in}(t_1)$$

But this is the charge that will be transferred to C during phase Φ_2
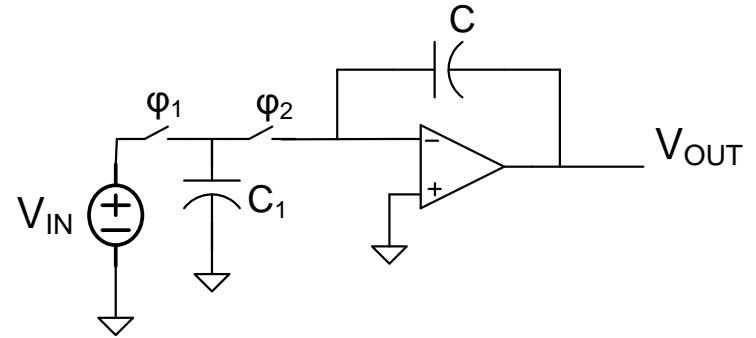
$$Q_{SC} \simeq C_1 V_{in}(t_1)$$

Observe that the SC circuit also transfers charge proportional to V_{in} in short intervals of length T_{CLK}

$$T(s) = -\frac{1}{RCs}$$
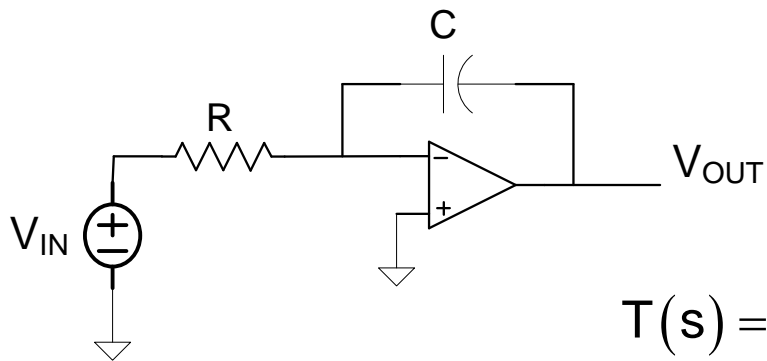
$$I_0 = \frac{1}{RC}$$

Comparing the two circuits

$$Q_{RC} \simeq \left[\frac{V_{in}(t_1)}{R}\right] T_{CLK} \qquad Q_{SC} \simeq C_1 V_{in}(t_1)$$

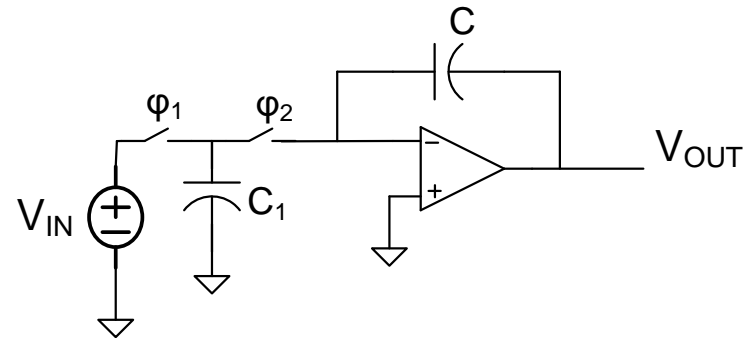Equating charges since both proportional to $V_{in}(t_1)$

$$C_1 \simeq \left[\frac{1}{R}\right] T_{CLK}$$

$$R_{EQ} \simeq \frac{1}{f_{CLK} C_1}$$

$$T(s) = -\frac{1}{RCs}$$

$$I_0 = \frac{1}{RC}$$

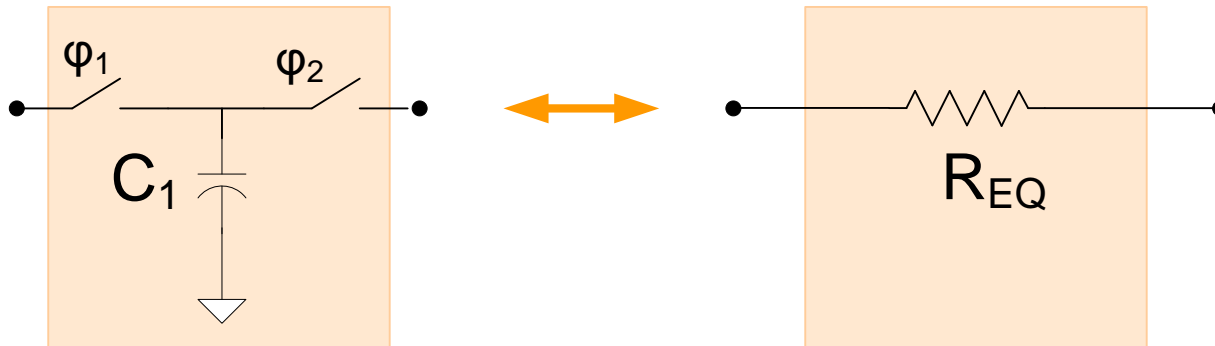$$R_{EQ} \simeq \frac{1}{f_{CLK}C_1}$$

Observe that a switched-capacitor behaves as a resistor!

This is an interesting observation that was made by Maxwell over 100 years ago but in and of itself was of almost no consequence

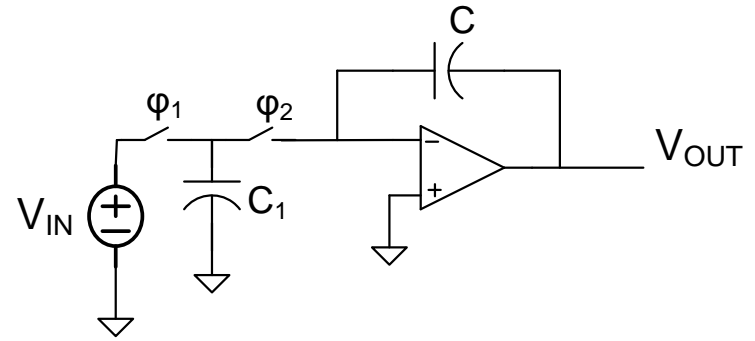Note that large resistors require small capacitors !

This offers potential for overcoming <u>one</u> of the critical challenges for Implementing integrators on silicon at audio frequencies!

Equivalence Between Rapidly Switched Capacitor and Resistor

$$R_{EQ} \simeq \frac{1}{f_{CLK}C_1}$$

Consider again the SC integrator

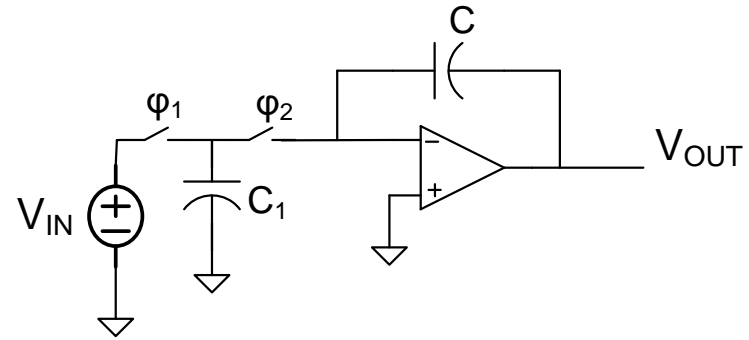$$T_{SC}(s) \simeq \frac{-1}{R_{EQ}Cs}$$

$$R_{EQ} \simeq \frac{1}{f_{CLK}C_1}$$

$$I_{0eq} = \frac{1}{R_{EQ}C}$$

$$I_{0eq} = \frac{1}{R_{EQ}C} = \frac{C_1 f_{CLK}}{C}$$

$$I_{0eq} = \left[\frac{C_1}{C}\right] f_{CLK}$$

This is a frequency referenced filter!

Consider again the SC integrator

$$T_{SC}(s) \simeq \frac{-1}{R_{EQ}Cs}$$

$$R_{EQ} \simeq \frac{1}{f_{CLK}C_1}$$

$$I_{0eq} = \left[\frac{C_1}{C}\right]f_{CLK}$$

The expressions $S_C^{I_0}$ and $S_{C_1}^{I_0}$ have the same magnitude as for the RC integrator

- But the ratio of capacitors can be accurately controlled in IC processes
  (1% to .01% is achievable with careful layout)
- f_{CLK} can be VERY accurately controlled with a crystal (1 part in 10^6 or better)
- Variability of I_{0eq} is very small

The SC integrator can dramatically reduce the second main concern for building integrated integrators

Consider again the SC integrator
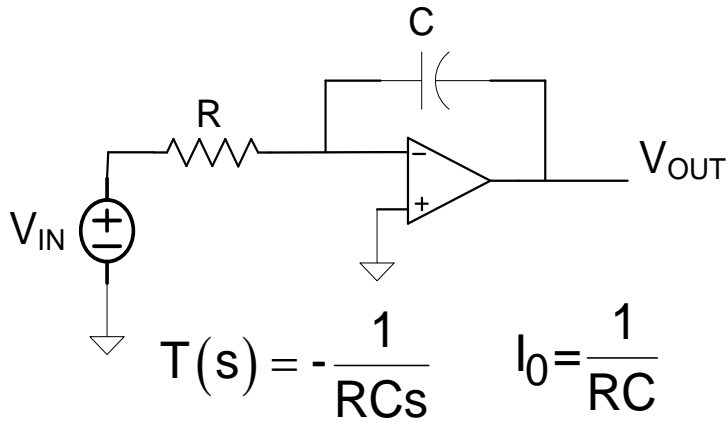
$$T(s) = -\frac{1}{RCs} \qquad I_0 = \frac{1}{RC}$$

$$I_{0eq} = \left[\frac{C_1}{C}\right] f_{CLK}$$

1. **Accuracy of R and C difficult to accurately control (often 2 or 3 orders of magnitude to variable)**

2. **Area of R and C too large in audio frequency range (2 or 3 orders of magnitude too large)**

3. **Amplifier GB limits performance**
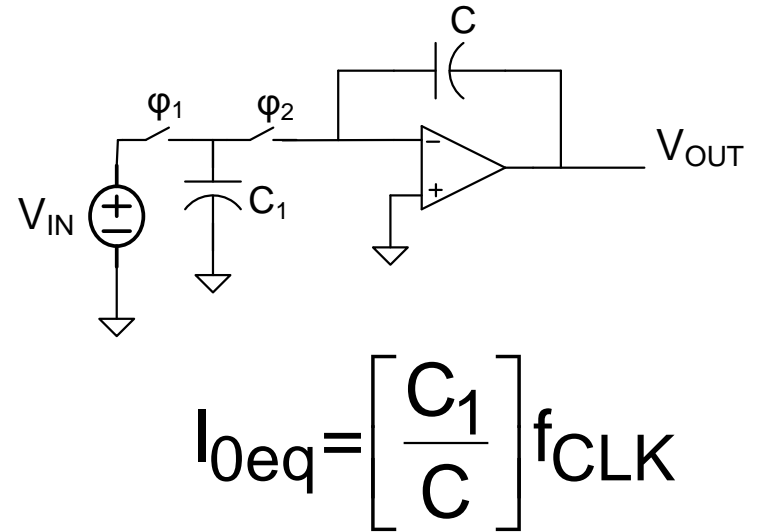
1. **Accuracy of cap ratio and f_{CLK} very good**

2. **Area of C1 and C not too large**

3. **Amplifier GB limits performance less**

The Genius !!
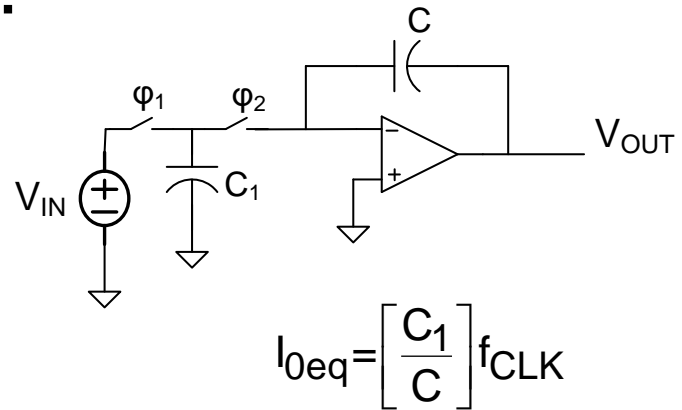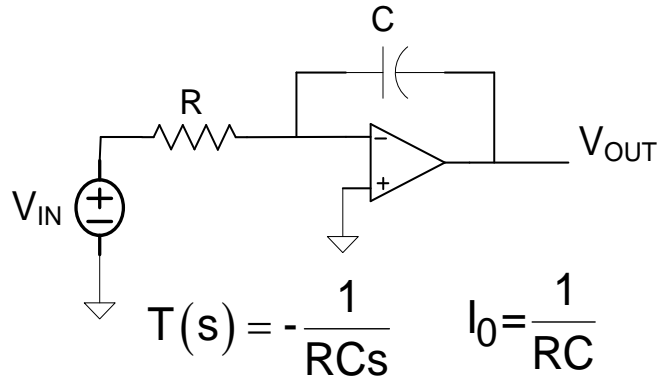
$$T(s) = -\frac{1}{RCs} \qquad I_0 = \frac{1}{RC}$$

$$I_{0eq} = \left[\frac{C_1}{C}\right] f_{CLK}$$

1. **Accuracy of R and C difficult to accurately control (often 2 or 3 orders of magnitude to variable)**

2. **Area of R and C too large in audio frequency range (2 or 3 orders of magnitude too large)**

3. **Amplifier GB limits performance**

1. **Accuracy of cap ratio and f_{CLK} very good**

2. **Area of C1 and C not too large**

3. **Amplifier GB limits performance less**

Observation of Maxwell (and other "Me Too" up until 1977) on equivalence of resistor and switched capacitor had no impact

Two groups independently observed items 1) and 2) in 1976/1977 timeframe and realized that practical implementations on silicon were possible and that is the genius of the concept
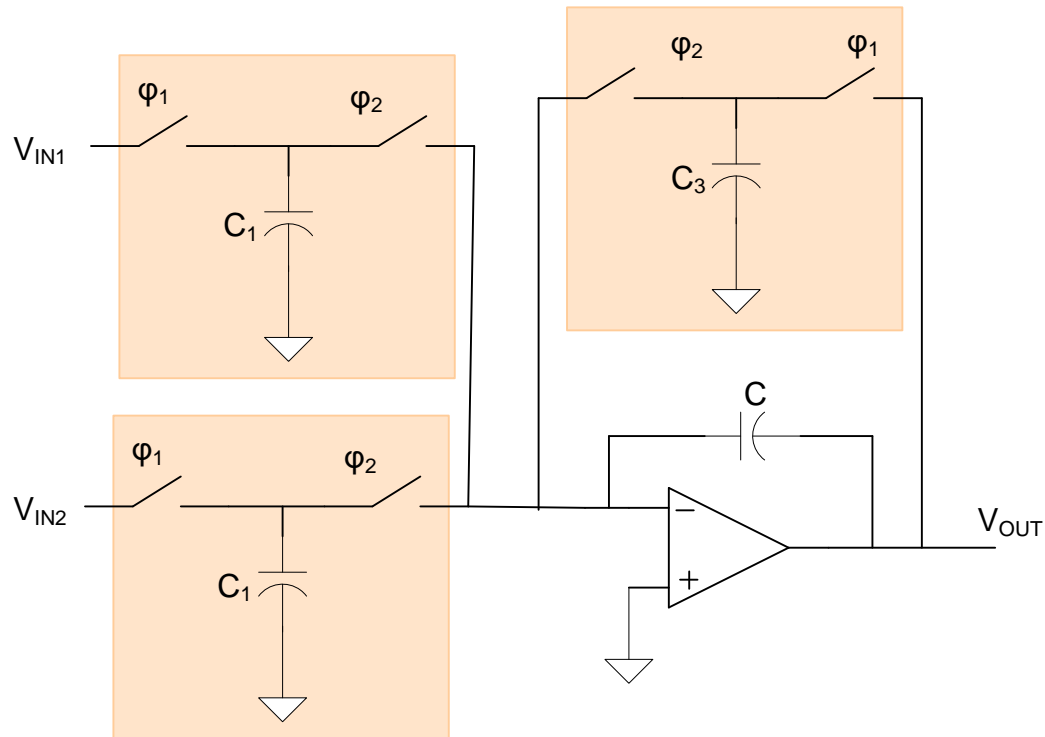
Switched Capacitors and the corresponding charge redistribution circuits now used well beyond the SC filter field

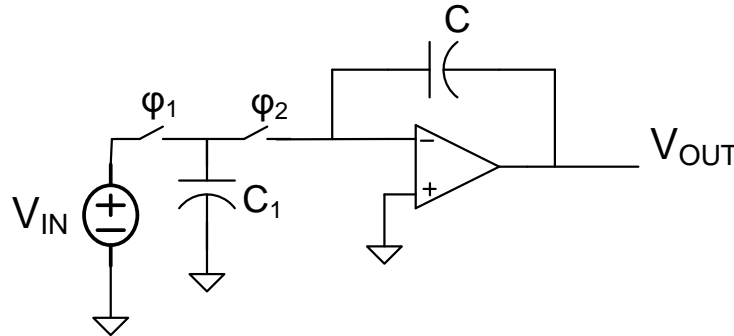Incredible enthusiasm and effort followed for better part of a decade

sC integrator with summing inputs
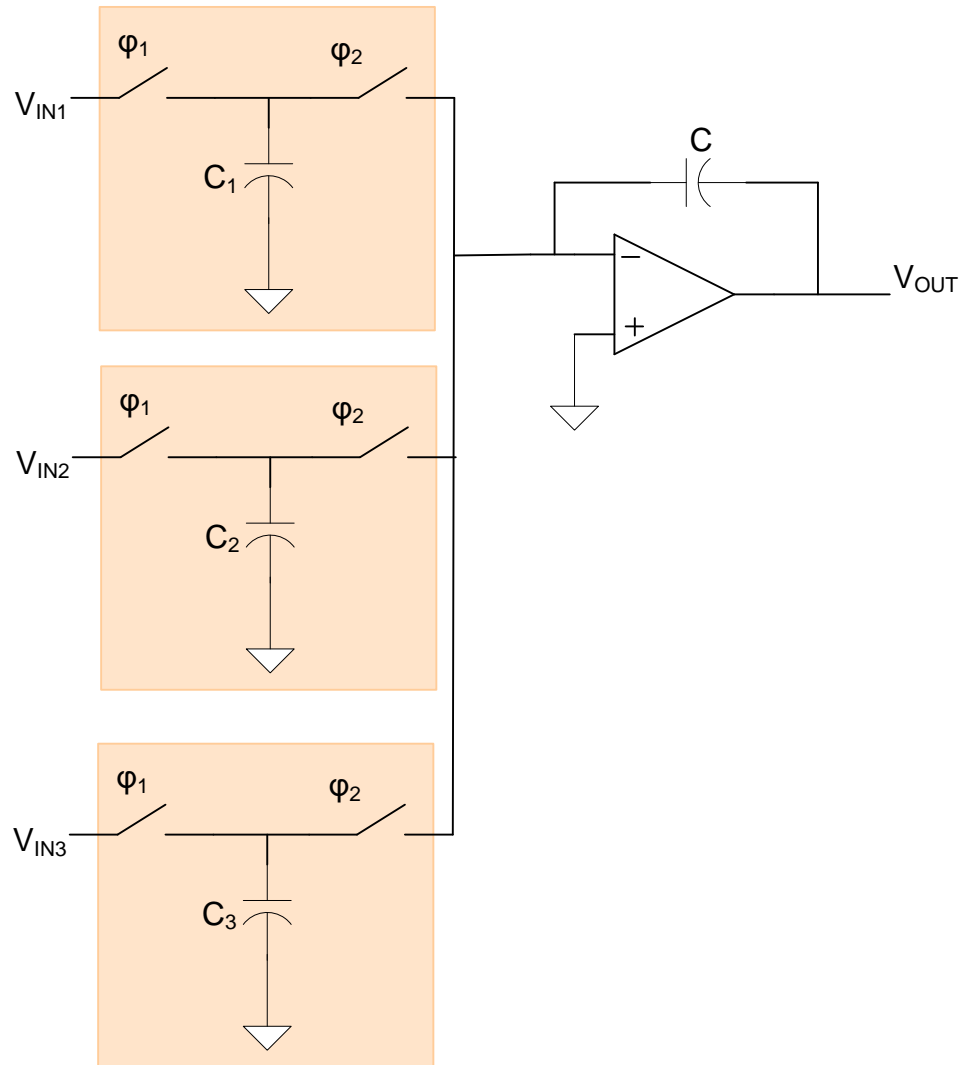
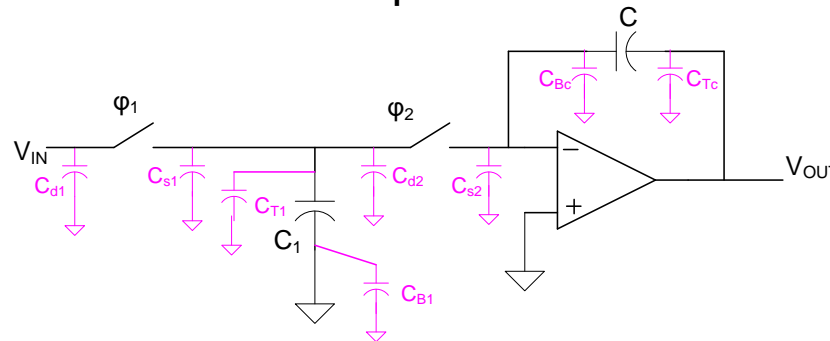# sC low-pass filter with summing inputs

Consider again the SC integrator

$$I_{0eq} = \left[\frac{C_1}{C} \right] f_{CLK}$$

Observe this circuit has considerable parasitics

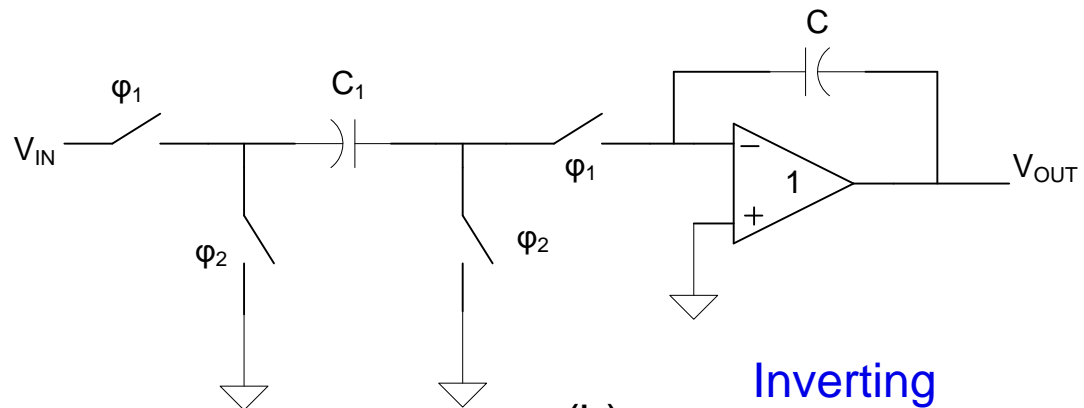
$$C_{1EQ} = C_1 + C_{s1} + C_{d2} + C_{T1}$$

Parasitic capacitors $C_{s1} + C_{d2} + C_{T1}$ difficult to accurately match

- Parasitic capacitors of THIS SC integrator limit performance
- Other SC integrators (discussed later) offer same benefits but are not affected by parasitic capacitors

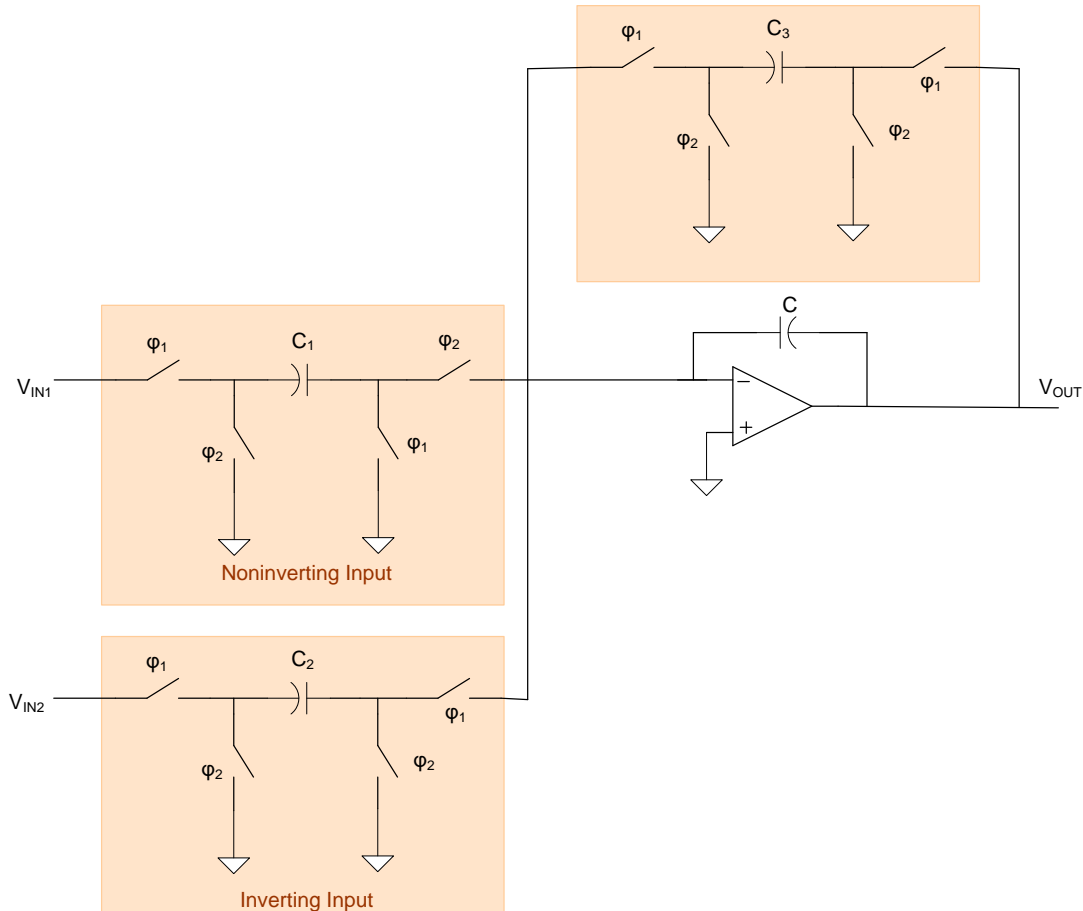# Stray insensitive Inverting and Noninverting SC integrators

(a) Noninverting
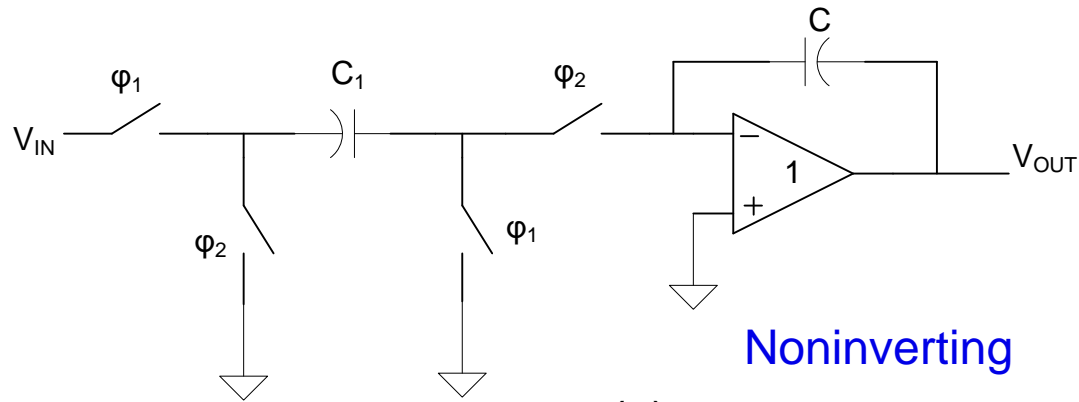
(b) Inverting

Stray Insensitive SC Low-Pass Filter with Inverting and Noninverting Inputs
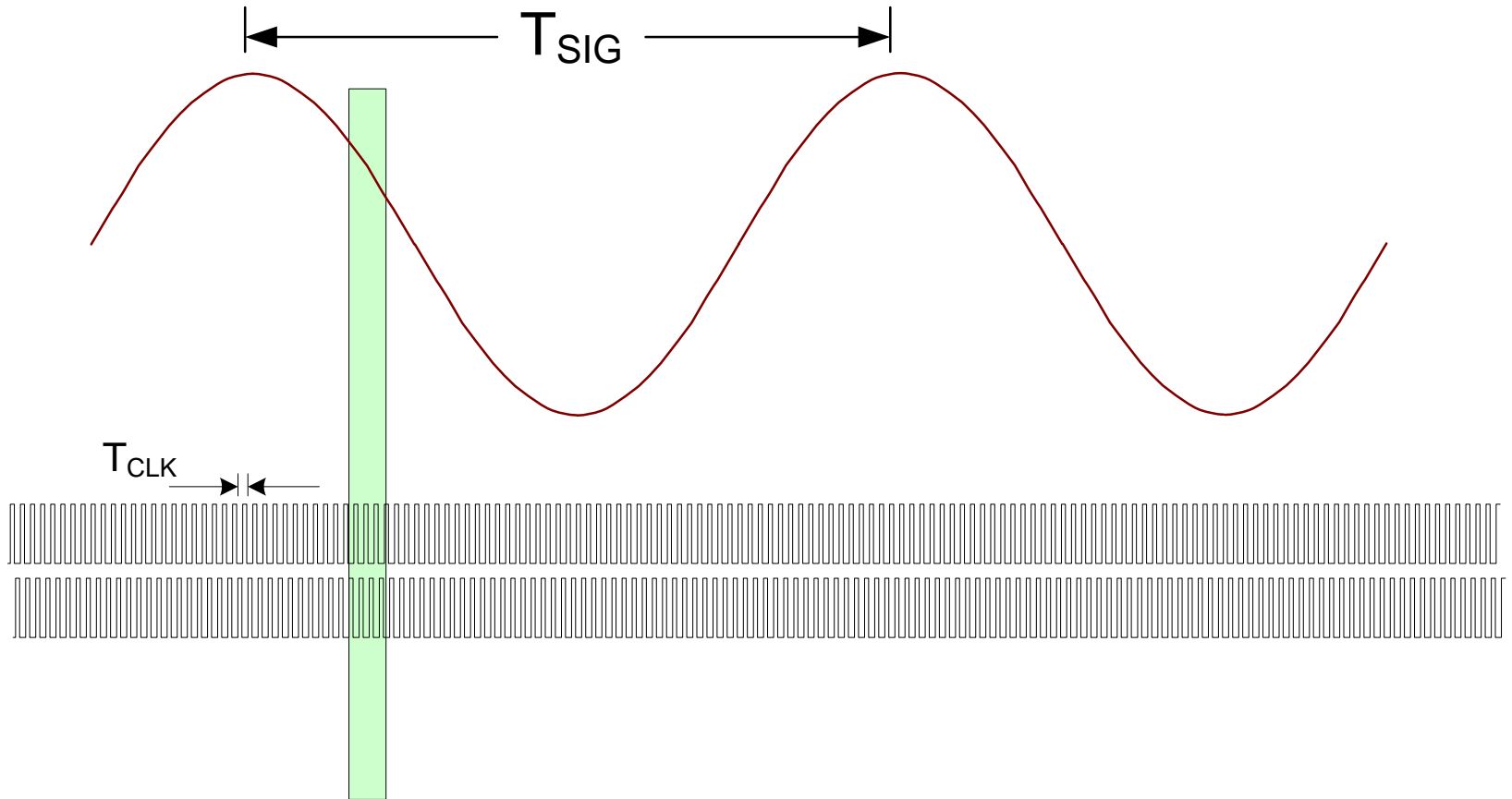

Arbitrary number of inverting and ioninverting Inputs can be added

Switched-Capacitor Filter Issues

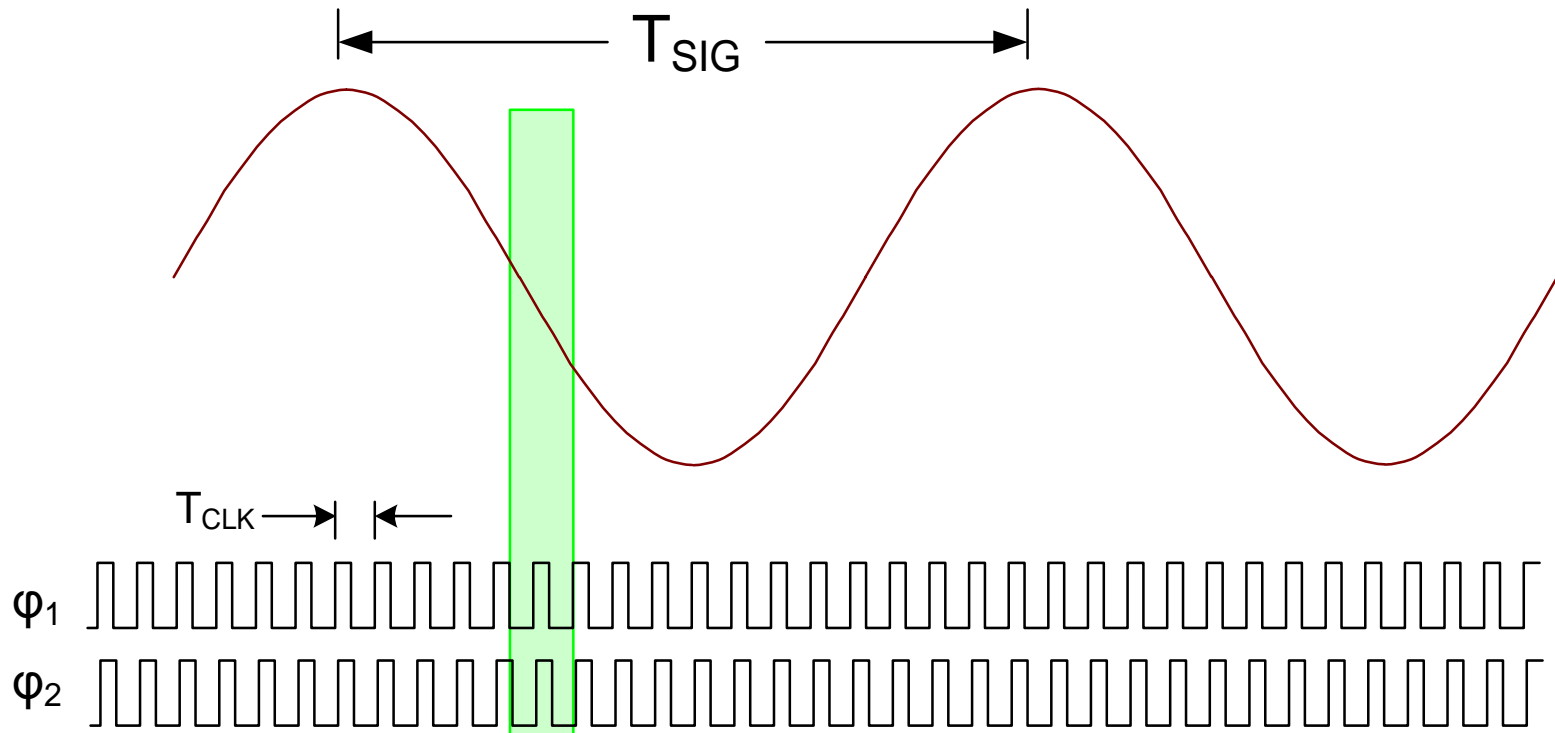What if T_{CLK} is not much-much smaller than T_{SIG}?

For $T_{CLK} \ll T_{SIG}$

Switched-Capacitor Filter Issues
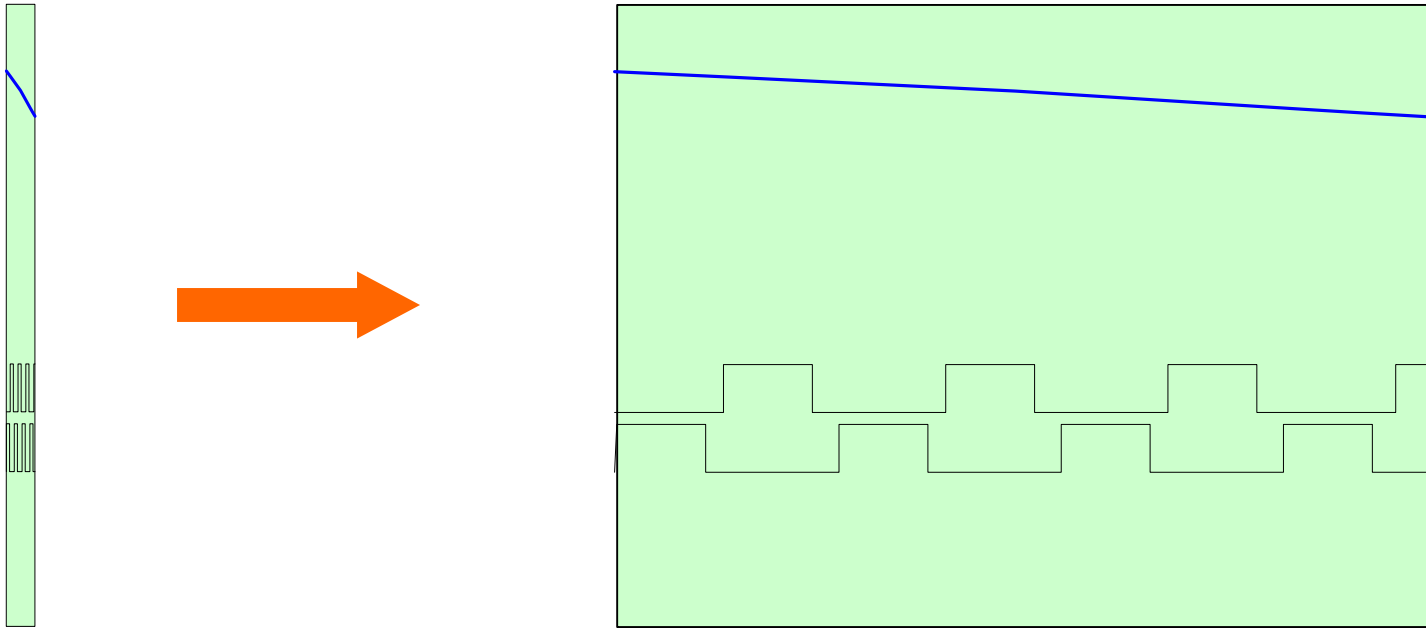
What if T_{CLK} is not much-much smaller than T_{SIG}?

For $T_{CLK} < T_{SIG}$

Switched-Capacitor Filter Issues

What if T_{CLK} is not much-much smaller than T_{SIG}?

For $T_{CLK} << T_{SIG}$

Switched-Capacitor Filter Issues

What if T_{CLK} is not much-much smaller than T_{SIG}?

For $T_{CLK} < T_{SIG}$

Switched-Capacitor Filter Issues

What if T_{CLK} is not much-much smaller than T_{SIG}?

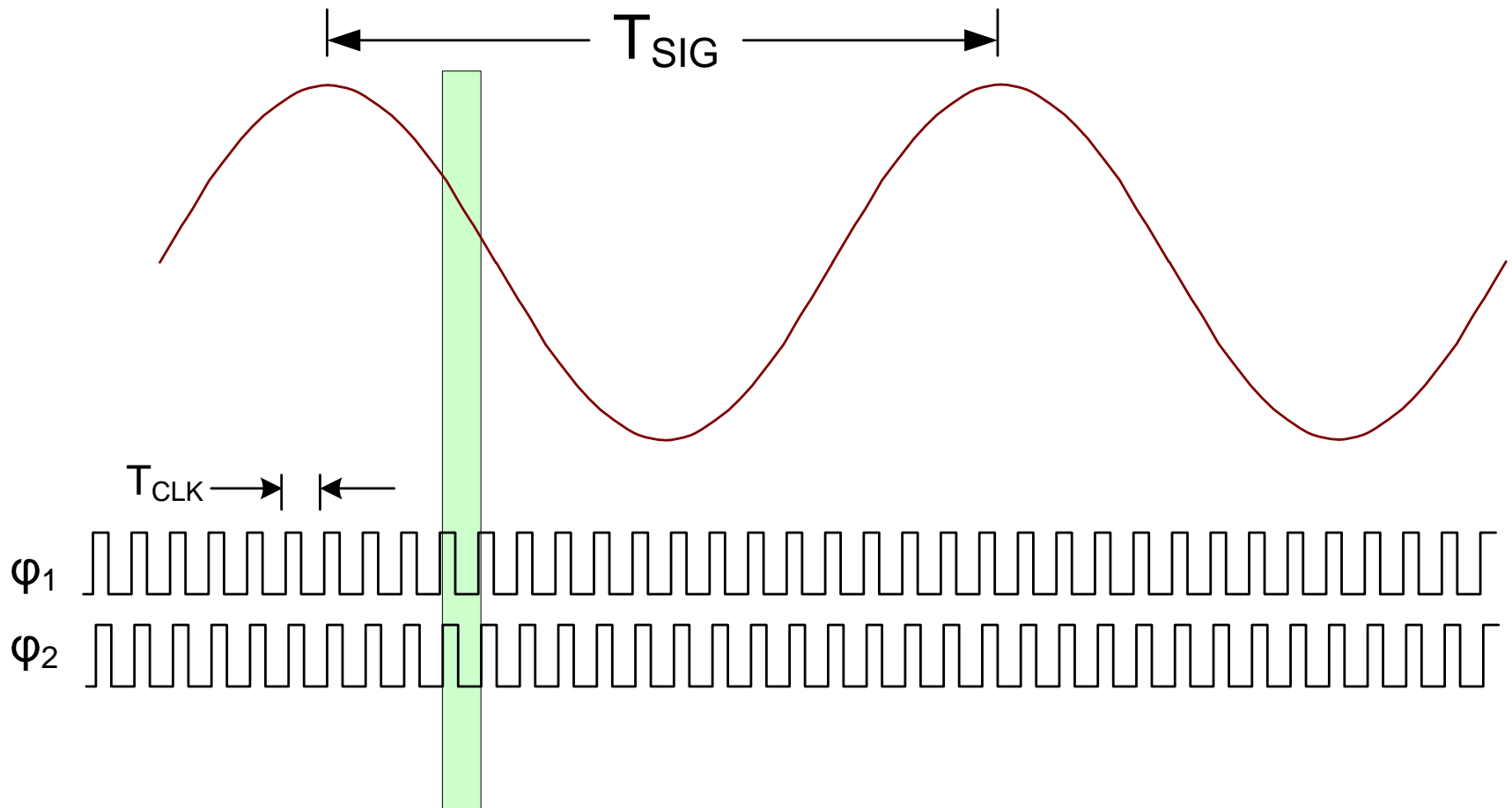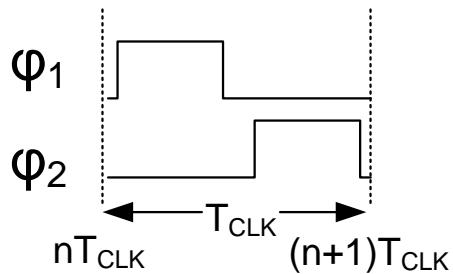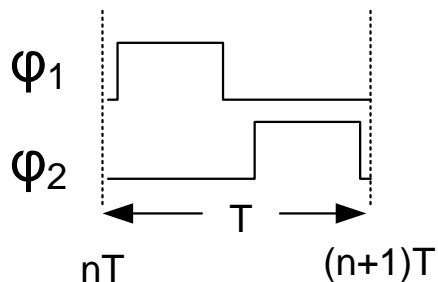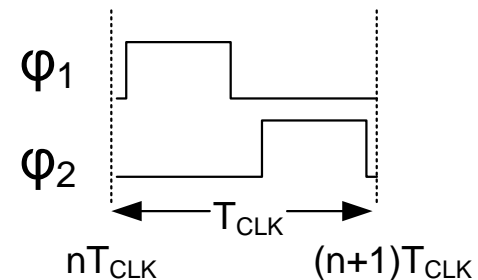For $T_{CLK} << T_{SIG}$

$V(nT)$ ———— $V((n+1)T)$

φ_1

φ_2

$\xleftarrow{T_{CLK}}$

nT_{CLK} $(n+1)T_{CLK}$

Define $T = T_{CLK}$

φ_1

φ_2

$\xleftarrow{T}$

nT $(n+1)T$

For $T_{CLK} < T_{SIG}$

$V(nT)$

$V((n+1)T)$

φ_1

φ_2

$\xleftarrow{T_{CLK}}$

nT_{CLK} $(n+1)T_{CLK}$

Define $T = T_{CLK}$

φ_1

φ_2

$\xleftarrow{T}$

nT $(n+1)T$

Considerable change in $V(t)$ in clock period

Switched-Capacitor Filter Issues

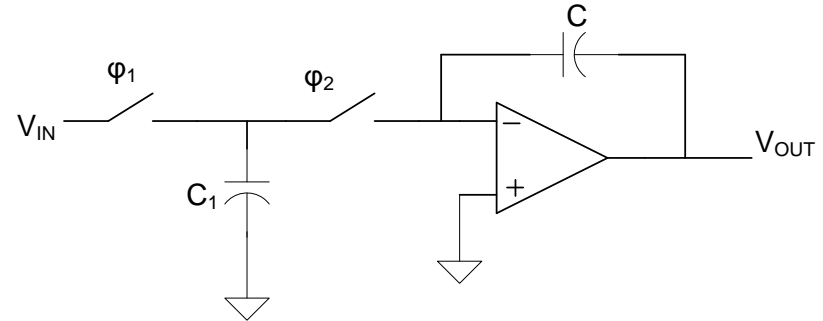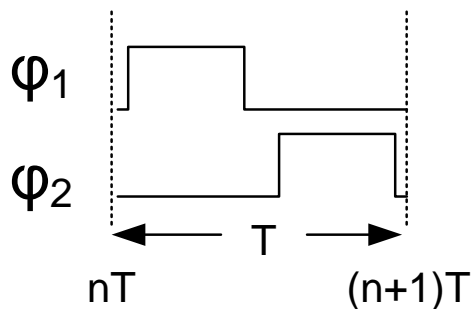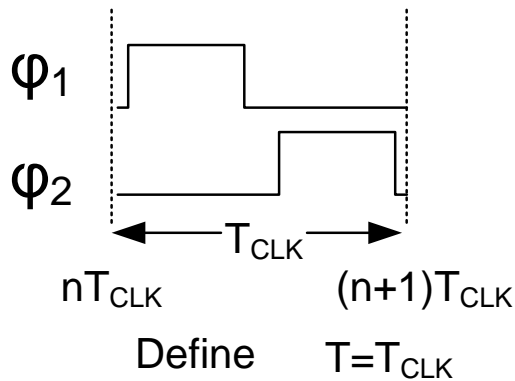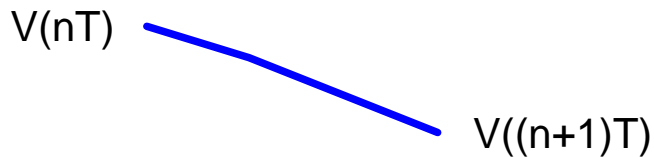## What if T_{CLK} is not much-much smaller than T_{SIG}?

For $T_{CLK} < T_{SIG}$

$$V_0(nT+T) = V_0(nT) + \frac{\Delta Q}{C}$$

but $-\Delta Q$ is the charge on C_1 and the time φ_1 opens

$$-\Delta Q \simeq C_1 V_{IN}(nT+T/2)$$

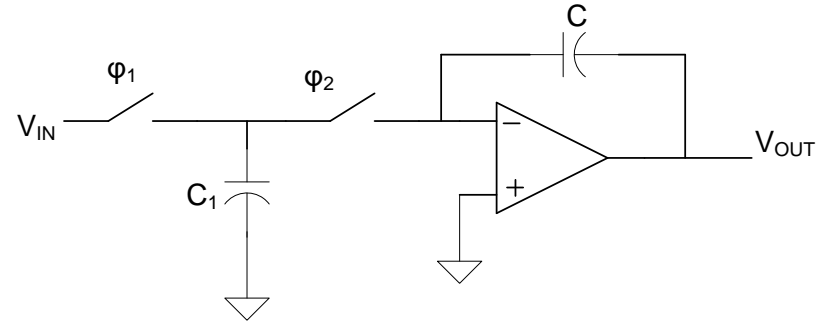$$\therefore V_{OUT}(nT+T) = V_{OUT}(nT) - (C_1/C)V_{IN}(nT+T/2)$$

If an input S/H, V_{IN} constant over periods of length T
thus, assume $V_{IN}(nT+T/2) \simeq V_{IN}(nT)$
So obtain

$$V_{OUT}(nT+T) = V_{OUT}(nT) - (C_1/C)V_{IN}(nT)$$

Switched-Capacitor Filter Issues
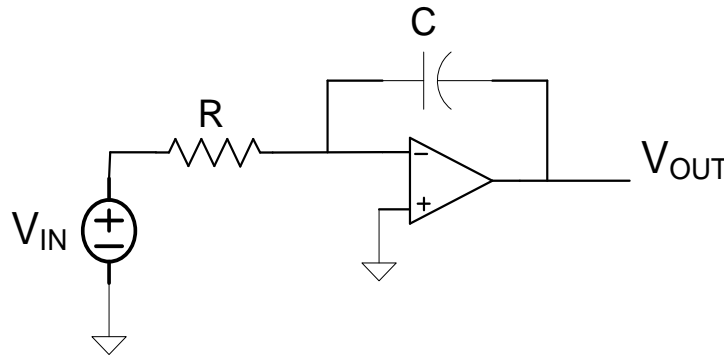
What if T_{CLK} is not much-much smaller than T_{SIG}?

$$V_{OUT}(nT+T)=V_{OUT}(nT)-(C_1/C)V_{IN}(nT)$$

for any T_{CLK}, characterized in time domain by difference equation

or in frequency domain characterized by transfer function obtained by taking z-transform of the difference equation

$$H(z)=-\frac{C_1/C}{z-1}$$

What is really required for building a filter that has high-performance features?

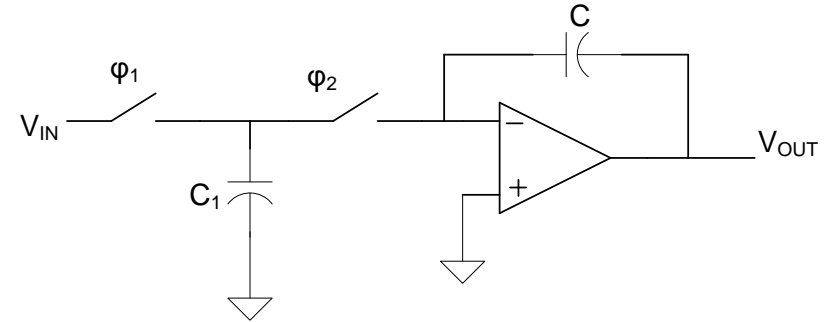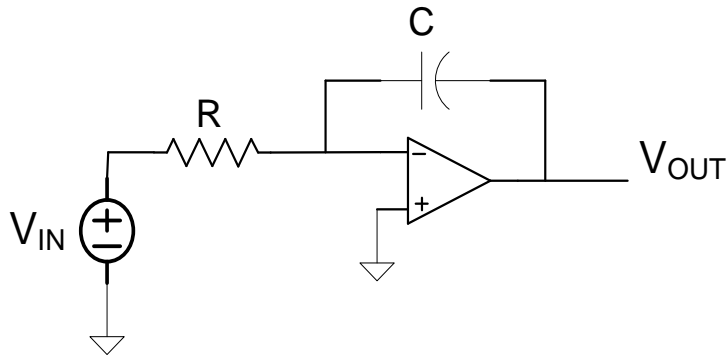Frequency domain:

Transfer function

$$T(s)=\frac{1}{RCs}$$

Time domain:

Differential Equation

$$V_{OUT}(t)=V_{OUT}(t_0)+\frac{1}{RC}\int_{t_0}^{t}V_{IN}(\tau)d\tau$$

Accurate control of polynomial coefficients in transfer function or accurate control of coefficients in the differential equation

What is really required for building a filter that has high-performance features?

Frequency domain:

Transfer function

$$T(s)=\frac{1}{RCs}$$

$$H(z)=-\frac{C_1/C}{z-1}$$

Time domain:

Differential Equation

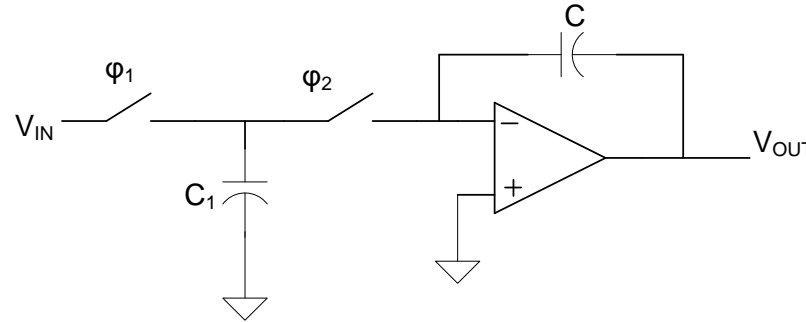$$V_{OUT}(t)=V_{OUT}(t_0)+\frac{1}{RC}\int_{t_0}^{t}V_{IN}(\tau)d\tau$$

Difference Equation

$$V_{OUT}(nT+T)=V_{OUT}(nT)-(C_1/C)V_{IN}(nT)$$

Accurate control of polynomial coefficients in transfer function or accurate control of coefficients in the differential/difference equation

Switched-Capacitor Filter Issues

What if T_{CLK} is not much-much smaller than T_{SIG}?

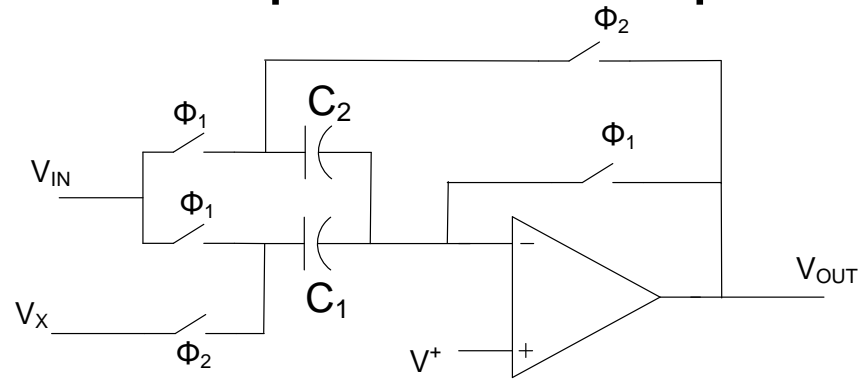$$V_{OUT}(nT+T)=V_{OUT}(nT)-(C_1/C)V_{IN}(nT)$$

$$H(z)=-\frac{C_1/C}{z-1}$$
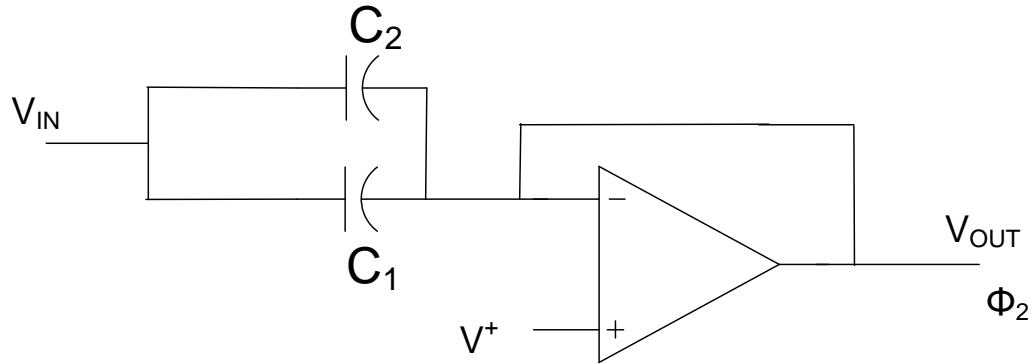
Switched-capacitor circuits have potential for good accuracy and attractive area irrespective of how T_{CLK} relates to T_{SIG}

But good layout techniques and appropriate area need to be allocated to realize this potential !

Consider the following circuit

Termed a flip-around amplifier

Clock signals are complimentary non-overlapping

The flip-around amplifier

During Φ_1

The flip-around amplifier
During Φ_1
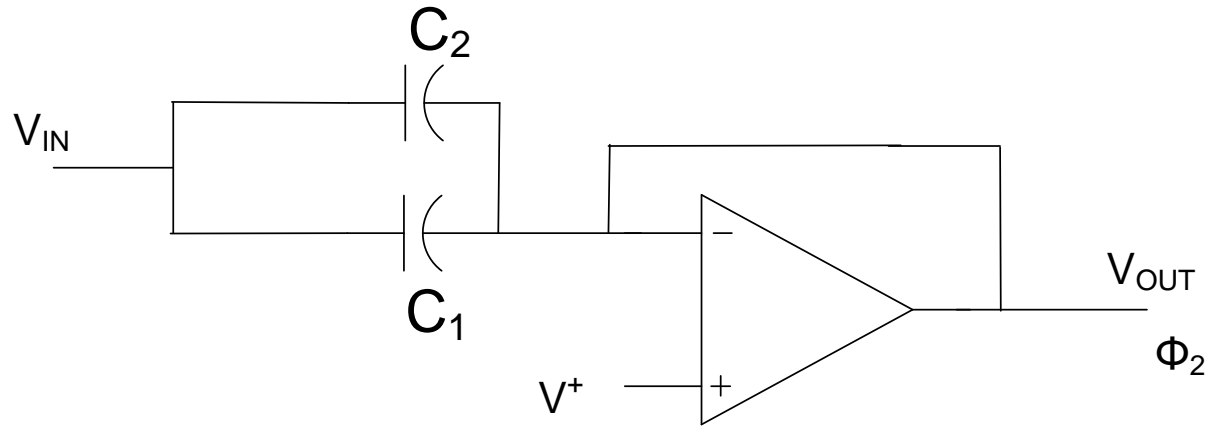
$$Q_1 = C_1\left(V_{IN} - V^+\right)$$
$$Q_2 = C_2\left(V_{IN} - V^+\right)$$

The flip-around amplifier

Φ_2

Φ_1 C_2

V_{IN}

Φ_1 Φ_1

V_X C_1

Φ_2 V^+ V_{OUT}

During Φ_2

C_2

V_X C_1

V^+ V_{OUT}
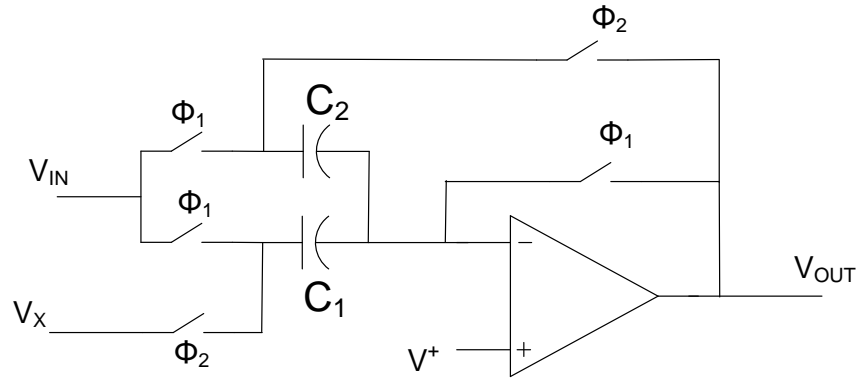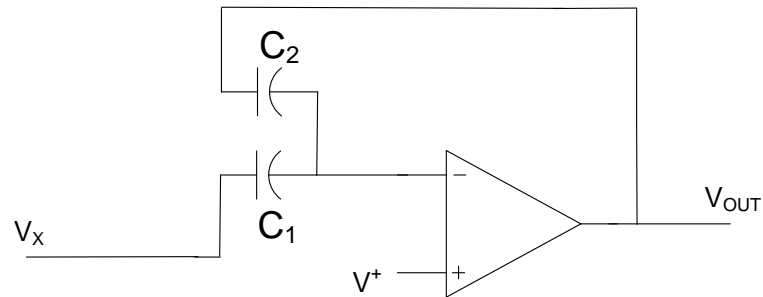
The flip-around amplifier

During Φ_2

$$Q_1 = C_1\left(V_{IN} - V^+\right)$$
$$Q_2 = C_2\left(V_{IN} - V^+\right)$$

V_X

C_2

C_1

V^+
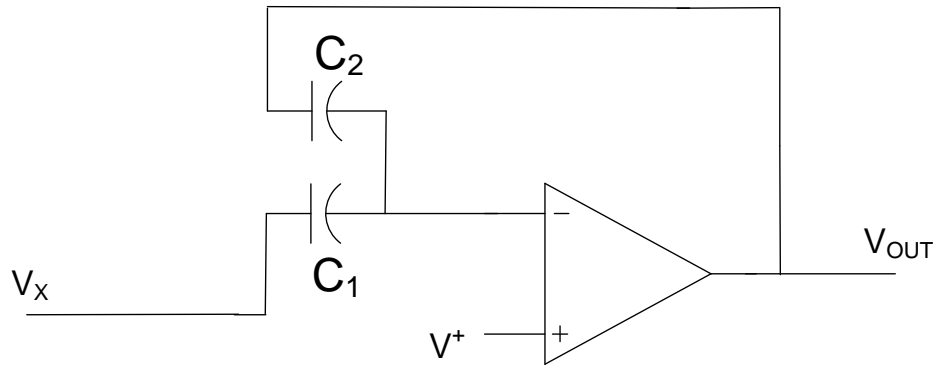
V_{OUT}

$$Q_{1T} = C_1\left(V_{IN} - V^+\right) - C_1\left(V_X - V^+\right) = C_1\left(V_{IN} - V_X\right)$$

$$Q_{2F} = Q_2 + Q_{1T} = C_2\left(V_{IN} - V^+\right) + C_1\left(V_{IN} - V_X\right) = \left(C_1 + C_2\right)V_{IN} - C_2 V^+ - C_1 V_X$$

The flip-around amplifier

During Φ_2
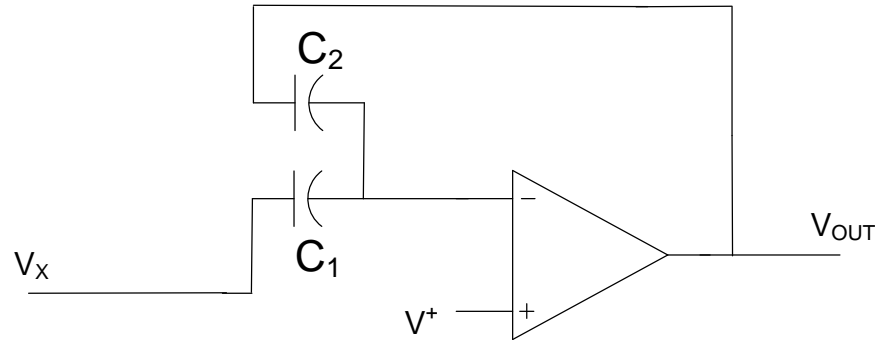
$$Q_{2F} = Q_2 + Q_{1T} = C_2\left(V_{IN} - V^+\right) + C_1\left(V_{IN} - V_X\right) = \left(C_1 + C_2\right)V_{IN} - C_2 V^+ - C_1 V_X$$
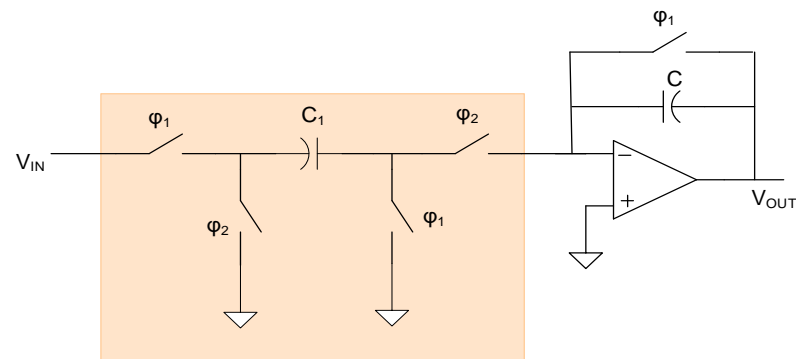
$$V_{C2F} = \frac{Q_{2F}}{C_2} = \left(1 + \frac{C_1}{C_2}\right)V_{IN} - V^+ - \frac{C_1}{C_2}V_X$$

$$V_{OUTF} = V_{C2F} + V^+ = \left(1 + \frac{C_1}{C_2}\right)V_{IN} - \frac{C_1}{C_2}V_X$$

Comparison of Flip Around Amplifier with previous SC amplifier
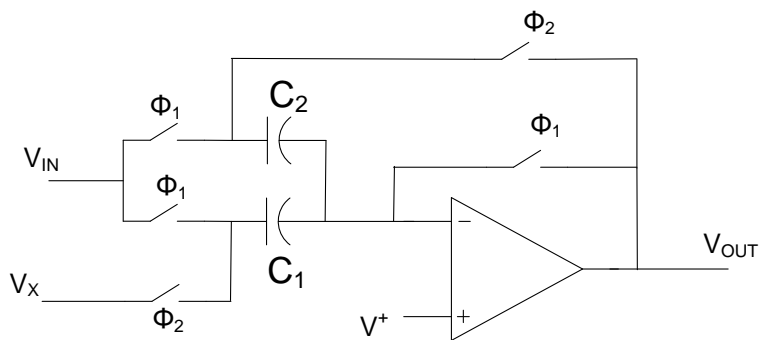
$$V_{OUTF} = \left(1 + \frac{C_1}{C_2}\right) V_{IN} - \frac{C_1}{C_2} V_X$$

$$V_{OUTF} = \frac{C_1}{C_2} V_{IN}$$

If $V_X=0$, both have a positive gain but somewhat more gain for a given capacitor ratio for the flip-around structure

In both cases, gain accuracy dependent upon how closely the capacitor ratios can be controlled

One particularly useful application is where want dc gain equal to 2 (1-bit/stage pipeline ADC)

Flip-around requires matching two capacitors, other requires ratio matching of two capacitors
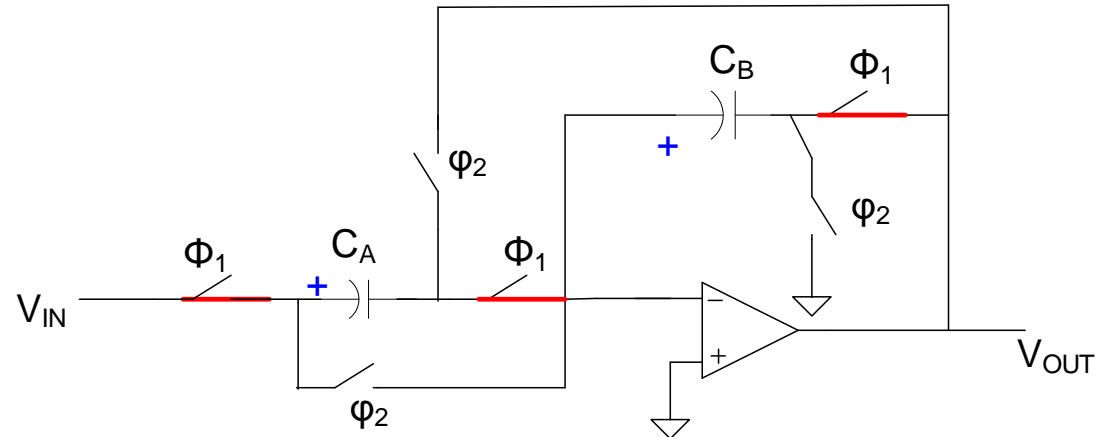
Another Flip Around Amplifier
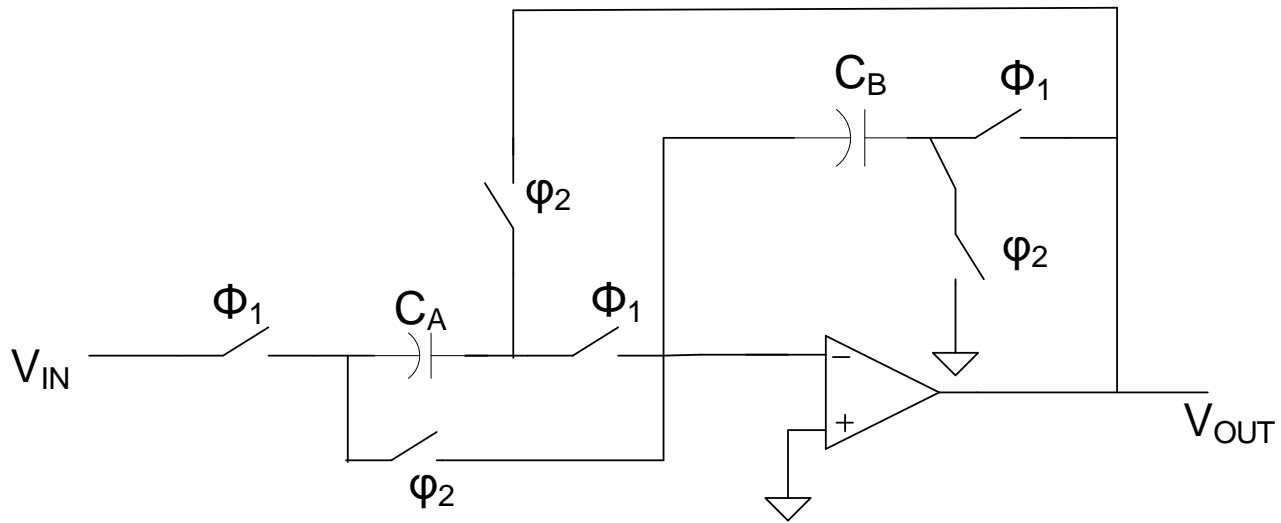
Clock signals are complimentary non-overlapping

Another Flip Around Amplifier

During phase φ_1

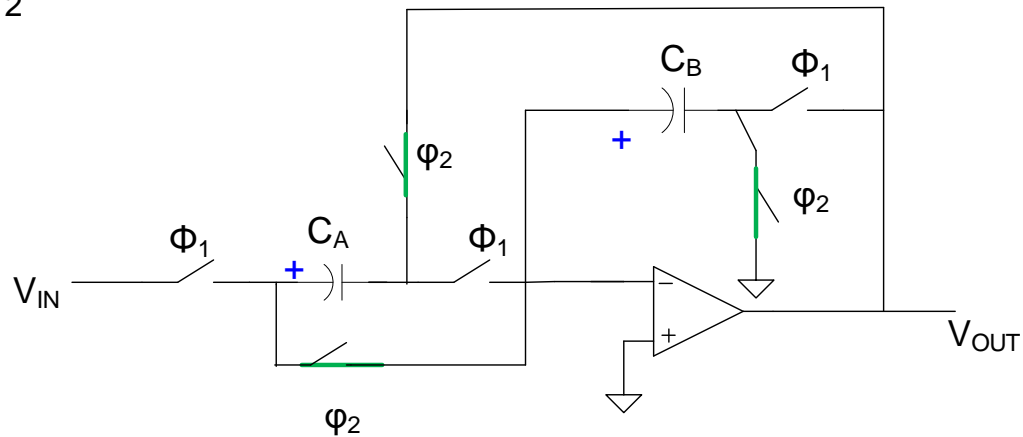Assume C_B discharged at start of phase – must verify later

$$Q_{CA1} = C_A V_{IN}$$
$$Q_{CB1} = C_A V_{IN}$$

$$V_{OUT} = -\frac{Q_{CB1}}{C_B} = -\frac{C_A}{C_B} V_{IN}$$

Another Flip Around Amplifier

During phase φ_2

From phase φ_1

$$Q_{CA1} = C_A V_{IN}$$

$$Q_{CB1} = C_A V_{IN}$$

$$\left. \begin{array}{l} Q_{CA2} = Q_{CA1} + Q_{CB1} \\ Q_{CB2} = 0 \end{array} \right\}$$

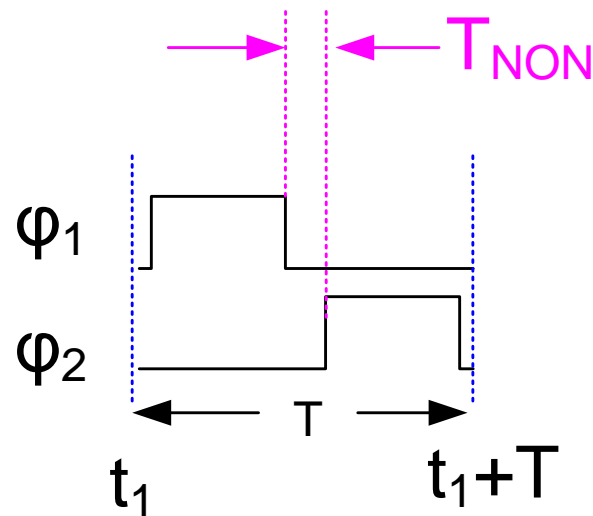$$V_{OUT} = -\frac{Q_{CA2}}{C_A}$$

$$V_{CB} = 0$$

Verified that C_B was discharged at the start of phase φ_1

$$V_{OUT} = -\frac{C_A V_{IN} + C_A V_{IN}}{C_A} = -2V_{IN}$$

This structure has a gain of 2 independent of any capacitor matching!

Can modify to get noninverting gain and gains of 3, 4, .., without matching requirements

Non-overlapping Clocks

- Essential that the clocks be non-overlapping
- Simple inverter to derive the complimentary clock will not work
- Must guarantee non-overlap in the presence of PVT variations
- In non-demanding speed applications, φ_1 and φ_2 will have 25% duty cycles

Stay Safe and Stay Healthy !

End of Lecture 38